

## THREE AND FOUR CELL LITHIUM-ION OR LITHIUM-POLYMER BATTERY PROTECTION AFE

### FEATURES

- 2-, 3-, or 4-Cell Series Protection Control
- Can Directly Interface With the bq2084 Gas Gauges
- Provides Individual Cell Voltages and Battery Voltage to Battery Management Host
- Integrated Cell Balancing Drive
- I<sup>2</sup>C Compatible User Interface Allows Access to Battery Information
- Programmable Threshold and Delay for Over Load and Short Circuit During Charge and Discharge
- System Alert Interrupt Output
- Host Control Can Initiate Sleep Power Mode and Ship Mode
- Integrated 3.3-V, 25-mA LDO
- Supply Voltage Range From 4.5 V to 25 V
- Low Supply Current of 60-μA Typical

### APPLICATIONS

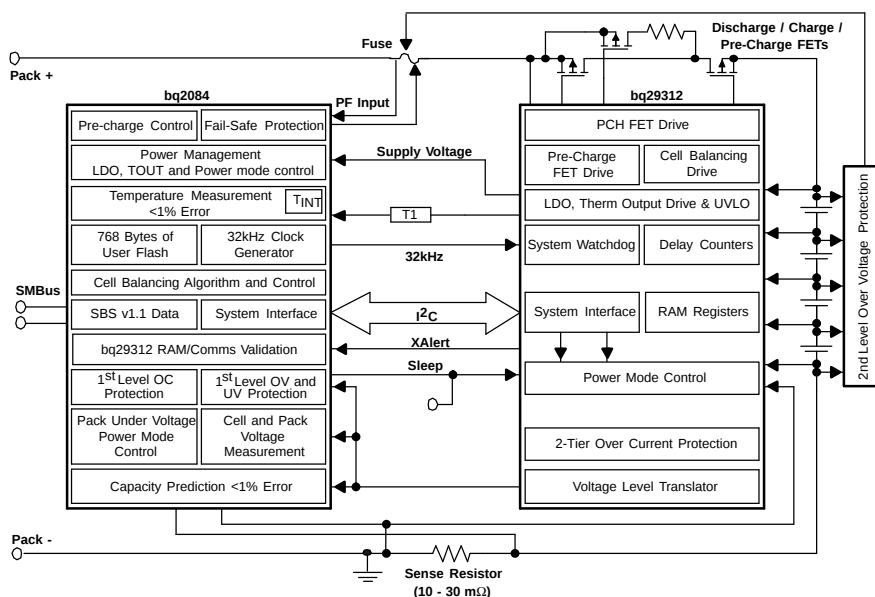
- Notebook PCs
- Medical and Test Equipment
- Portable Instrumentation

### DESCRIPTION

The bq29312 is a 2-, 3-, or 4-cell lithium-ion battery pack protection analog front end (AFE) IC that incorporates a 3.3-V, 25-mA low-dropout regulator (LDO). The bq29312 also integrates an I<sup>2</sup>C compatible interface to extract battery parameters such as cell voltages and control output status. Other parameters such as current protection thresholds and delays can be programmed into the bq29312 to increase the flexibility of the battery management system.

The bq29312 provides safety protection for over-charge, overload, short-circuit, overvoltage, and undervoltage conditions in conjunction with the battery management host. In overload and short-circuit conditions, the bq29312 turns the FET drive off autonomously dependant on the internal configuration setting.

### SYSTEM PARTITIONING DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## DESCRIPTION (Continued)

The communications interface allows the host to observe and control the current status of the bq29312. It enables cell balancing, enters different power modes, sets overload levels, sets the overload blanking delay time, sets short-circuit threshold levels for charge and discharge, and sets the short-circuit blanking delay time.

Cell balancing of each cell is performed via a cell bypass path, which is enabled via the internal control register accessible via the I<sup>2</sup>C compatible interface. The maximum bypass current is set via an external series resistor and internal FET on resistance (typical 400  $\Omega$ ).

## ORDERING INFORMATION

| $T_A$         | PACKAGED <sup>(1)</sup> |
|---------------|-------------------------|
|               | TSSOP (PW)              |
| –25°C to 85°C | bq29312PW<br>bq29312PWR |

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at [www.ti.com](http://www.ti.com).

## PACKAGE DISSIPATION RATINGS

| PACKAGE | POWER RATING<br>$T_A \leq 25^\circ\text{C}$ | DERATING FACTOR<br>ABOVE $T_A \leq 25^\circ\text{C}$ | POWER RATING                |                          |
|---------|---------------------------------------------|------------------------------------------------------|-----------------------------|--------------------------|
|         |                                             |                                                      | $T_A \leq 70^\circ\text{C}$ | $T_A = 85^\circ\text{C}$ |
| PW      | 874 mW                                      | 6.99 W/ $^\circ\text{C}$                             | 559 mW                      | 454 mW                   |

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted<sup>(1)(2)</sup>

|           |                                      |                                                | <b>bq29312</b>               |
|-----------|--------------------------------------|------------------------------------------------|------------------------------|
| $V_{SS}$  | Supply voltage range                 | PACK, BAT                                      | –0.3 V to 34 V               |
| $V_I$     | Input voltage range                  | VC1, VC2, VC3, VC4                             | –0.3 V to 34 V               |
|           |                                      | SR1, SR2                                       | –1.0 V to 1.0 V              |
|           |                                      | VC5                                            | –1.0 V to 4.0 V              |
|           |                                      | VC1 to VC2, VC2 to VC3, VC3 to VC4, VC4 to VC5 | –0.3 to 8.5 V                |
|           |                                      | WDI, SLEEP, SCLK, SDATA                        | –0.3 to 8.5 V                |
|           |                                      | ZVCHG                                          | –0.3 V to 34 V               |
| $V_O$     | Output voltage range                 | DSG, CHG                                       | –0.3 V to BAT                |
|           |                                      | OD                                             | –0.3 V to 34 V               |
|           |                                      | PMS                                            | –0.3 V to PACK – 0.2 V       |
|           |                                      | TOUT, SCLK, SDATA, CELL, XALERT                | –0.3 to 7 V                  |
|           | Current for cell balancing           |                                                | 10 mA                        |
|           | Continuous total power dissipation   |                                                | See Dissipation Rating Table |
| $T_{stg}$ | Storage temperature range            |                                                | –65°C to 150°C               |
|           | Lead temperature (soldering, 10 sec) |                                                | 300°C                        |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground of this device except  $VC_n - VC(n + 1)$ , where  $n = 1, 2, 3, 4$  cell voltage.

## RECOMMENDED OPERATING CONDITIONS

|                  |                                             |                                  | MIN                | NOM    | MAX        | UNIT |
|------------------|---------------------------------------------|----------------------------------|--------------------|--------|------------|------|
|                  | Supply Voltage (BAT or PACK)                |                                  | 4.5 <sup>(1)</sup> |        | 25         | V    |
| $V_{I(STARTUP)}$ | Start-up voltage (PACK)                     |                                  | 5.0                |        |            | V    |
| $V_I$            | Input voltage range                         | VC1, VC2, VC3, VC4               | 0                  |        | BAT        | V    |
|                  |                                             | SR1, SR2                         | –0.5               |        | 0.5        |      |
|                  |                                             | VC5                              | –0.5               |        | 3.0        |      |
|                  |                                             | VCn – VC(n+1), (n = 1, 2, 3, 4 ) | 0                  |        | 5.0        |      |
|                  |                                             | PMS                              | 0                  |        | PACK       |      |
|                  |                                             | SLEEP                            | 0                  |        | REG        |      |
| $V_{IH}$         | Logic level input voltage                   | SCLK, SDATA, WDI                 | 0.8×REG            |        | REG        | V    |
| $V_{IL}$         |                                             |                                  | 0                  |        | 0.2 × REG  |      |
| $V_{IH}$         | PMS logic level                             | PMS                              | $V_{PACK} - 0.2$   |        | $V_{PACK}$ | V    |
| $V_{IL}$         |                                             |                                  | 0                  |        | 0.2        |      |
|                  | PMS pull up/pull down resistance            | RPMS                             | 100                |        | 1000       | kΩ   |
| $V_O$            | Output voltage                              | OD                               |                    |        | 25         | V    |
| $I_O$            | Output current                              | XALERT, SDATA                    |                    |        | 200        | μA   |
| $I_I$            | Input current, External 3.3 V REG capacitor | CELL                             |                    |        | ±10        | μA   |
|                  |                                             | SLEEP                            | –0.5               |        | 1.0        | μA   |
|                  |                                             | $C_{(REG)}$                      | 4.7                |        |            | μF   |
|                  |                                             |                                  |                    |        |            |      |
|                  | Extend CELL output filter                   | $R_{(CELL)}$                     |                    | 100    |            | Ω    |
|                  |                                             | $C_{(CELL)}$                     |                    | 100    |            | nF   |
| $I_{OL}$         | Input frequency                             | OD                               |                    |        | 1          | mA   |
|                  |                                             | WDI                              |                    | 32.768 |            | kHz  |
|                  | WDI high time                               |                                  | 2                  |        | 28         | μs   |
| $T_A$            | Operating temperature                       |                                  | –25                |        | 85         | °C   |

- (1)  $V_{(PACK)}$  supply voltage must rise above start-up voltage on power up to enable the internal regulator which drives REG and TOUT as required. Once  $V_{(PACK)}$  is above the start-up voltage, it can fall down to the minimum supply voltage and still meet the specifications of the bq29312.

**ELECTRICAL CHARACTERISTICS**
 $T_A = 25^\circ\text{C}$ ,  $C_{(\text{REG})} = 4.7\ \mu\text{F}$ ,  $\text{BAT} = 14\ \text{V}$  (unless otherwise noted)

| PARAMETER               |                                                       | TEST CONDITIONS                                                                                                                       | MIN                            | TYP   | MAX         | UNIT  |   |
|-------------------------|-------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------|--------------------------------|-------|-------------|-------|---|
| SUPPLY CURRENT          |                                                       |                                                                                                                                       |                                |       |             |       |   |
| I <sub>CC1</sub>        | Supply current 1                                      | No load at REG, TOUT, XALERT, SCLK, and SDATA.<br>ZVCHG = off ,VMEN = on, WDI no clock,<br>Select VC5 = VC4 = 0 V                     |                                | 60    | 90          | μA    |   |
|                         |                                                       | T <sub>A</sub> = −25°C to 85°C                                                                                                        |                                |       | 100         |       |   |
| I <sub>CC2</sub>        | Supply current 2<br>(Depends of VM topology selected) | No load at REG, TOUT, XALERT, SCLK, and SDATA.<br>ZVCHG = off, VMEN = off, WDI no clock                                               | T <sub>A</sub> = −25°C to 85°C | 25    | 50          | μA    |   |
| I <sub>(SLEEP)</sub>    | Sleep current                                         | No load at REG, TOUT, XALERT, SCLK, and<br>SDATA.CHG, DSG and ZVCHG = off, REG = on,<br>VMEN = off, WDI no clock, SLEEP = REG or OPEN | T <sub>A</sub> = −25°C to 85°C | 20    | 40          | μA    |   |
| I <sub>(SHIP)</sub>     | Ship current                                          | REG, CHG, DSG and ZVCHG = off, REG = off,<br>VMEN = off, WDI no clock, VPACK= 0 V                                                     | T <sub>A</sub> = −25°C to 85°C | 0.1   | 1.0         | μA    |   |
| 3.3 V LDO               |                                                       |                                                                                                                                       |                                |       |             |       |   |
| V <sub>(REG)</sub>      | Regulator output voltage                              | 8.0 V < BAT or PACK ≤ 25 V, I <sub>O</sub> ≤ 25 mA                                                                                    | T <sub>A</sub> = −25°C to 85°C | −4%   | 3.3         | 2%    | V |
|                         |                                                       | 6.5 V < BAT or PACK ≤ 8 V, I <sub>O</sub> ≤ 25 mA                                                                                     |                                | −9%   | 3.3         | 2%    |   |
|                         |                                                       | 5.4 V ≤ BATor PACK ≤ 6.5 V, I <sub>O</sub> ≤ 16 mA                                                                                    |                                | −9%   | 3.3         | 2%    |   |
|                         |                                                       | 4.5 V ≤ BAT or PACK ≤ 25 V, I <sub>O</sub> ≤ 2 mA                                                                                     |                                | −2%   | 3.3         | 2%    |   |
| ΔV <sub>(EGTEMP)</sub>  | Regulator output change with temperature              | 5.4 V ≤ BAT ≤ 25 V, I <sub>O</sub> = 2 mA,                                                                                            | T <sub>A</sub> = −25°C to 85°C | ±0.2% |             |       |   |
| ΔV <sub>(REGLINE)</sub> | Line regulation                                       | 5.4 V ≤ BAT or PACK ≤ 25 V, I <sub>O</sub> = 2 mA                                                                                     |                                | 3     | 10          | mV    |   |
| ΔV <sub>(REGLOAD)</sub> | Load regulation                                       | BAT = 14 V, 0.2 mA ≤ I <sub>O</sub> ≤ 2 mA                                                                                            |                                | 7     | 15          | mV    |   |
|                         |                                                       | BAT = 14 V, 0.2 mA ≤ I <sub>O</sub> ≤ 25 mA                                                                                           |                                | 40    | 100         |       |   |
| I <sub>MAX</sub>        | Current limit                                         | BAT = 14 V, REG = 3.0 V                                                                                                               |                                | 25    | 100         | mA    |   |
|                         |                                                       | BAT = 14 V, REG = 0 V                                                                                                                 |                                | 12    | 50          |       |   |
| CELL VOLTAGE MONITOR    |                                                       |                                                                                                                                       |                                |       |             |       |   |
| V <sub>(CELL OUT)</sub> | CELL output                                           | V <sub>(Cn)</sub> − V <sub>(Cn + 1)</sub> = 0 V, 8.0 V ≤ BAT or PACK ≤ 25 V                                                           |                                | 0.975 |             | V     |   |
|                         |                                                       | V <sub>(Cn)</sub> − V <sub>(Cn + 1)</sub> = 4.5 V, 8.0 V ≤ BAT or PACK ≤ 25 V                                                         |                                | 0.3   |             |       |   |
| REF                     | CELL output                                           | Mode <sup>(1)</sup> , 8.0 V ≤ BAT or PACK ≤ 25 V                                                                                      |                                | −1%   | 0.975       | 1%    | V |
| PACK                    | CELL output                                           | Mode <sup>(2)</sup>                                                                                                                   |                                | −5%   | PACK/<br>25 | 5%    | V |
| K                       | CELL scale factor                                     | K = (CELL output (VC5 = 0.0 V, VC4 = 4.5 V)<br>− CELL output (VC5 = VC4 = 0.0 V)/ 4.5                                                 |                                | 0.147 | 0.150       | 0.153 |   |
|                         |                                                       | K = (CELL output (VC2 = 13.5 V, VC1 = 18.0 V)<br>− CELL output (VC2 = VC1 = 13.5 V)/ 4.5                                              |                                | 0.147 | 0.150       | 0.153 |   |
| VICR                    | CELL output offset error                              | CELL output (VC2 = 17.0 V, VC1 = 17.0 V)<br>CELL output (VC2 = VC1 = 0.0 V)                                                           |                                | −1    |             | mV    |   |
| R <sub>(BAL)</sub>      | Cell balance internal resistance                      | rds(ON) for internal FET switch at V <sub>DS</sub> = 2.0 V                                                                            |                                | 200   | 400         | 800   | Ω |

(1) Register Address = 0x04, b2(CAL0) = b3(CAL1) = 1, Register Address = 0x03, b0(VMEN) = 1

(2) Register Address = 0x03, b1(PACKOUT) = 1, b0(VMEN) = 1

## ELECTRICAL CHARACTERISTICS (Continued)

$T_A = 25^\circ\text{C}$ ,  $C_{(\text{REG})} = 4.7 \mu\text{F}$ ,  $\text{BAT} = 14 \text{ V}$  (unless otherwise noted)

| PARAMETER                                       |                                                      | TEST CONDITION                                                                                                                            |                                                        | MIN  | NOM | MAX  | UNIT |
|-------------------------------------------------|------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------|------|-----|------|------|
| OVER LOAD (OL) AND SHORT CIRCUIT (SC) DETECTION |                                                      |                                                                                                                                           |                                                        |      |     |      |      |
| V <sub>OL</sub>                                 | OL detection threshold range, typical <sup>(1)</sup> |                                                                                                                                           |                                                        | −50  |     | −205 | mV   |
| ΔV <sub>OL</sub>                                | OL detection threshold program step                  |                                                                                                                                           |                                                        |      | 5   |      | mV   |
| V <sub>HYS(OL)</sub>                            | OL detection threshold hysteresis                    |                                                                                                                                           |                                                        | 7    | 10  | 13   | mV   |
| V <sub>(SC)</sub>                               | SC detection threshold range, typical <sup>(2)</sup> | Charge                                                                                                                                    |                                                        | 100  |     | 475  | mV   |
|                                                 |                                                      | Discharge                                                                                                                                 |                                                        | −100 |     | −475 |      |
| ΔV <sub>(SC)</sub>                              | SC detection threshold program step                  | Charge                                                                                                                                    |                                                        |      | 25  |      | mV   |
|                                                 |                                                      | Discharge                                                                                                                                 |                                                        |      | −25 |      |      |
| V <sub>HYS(SC)</sub>                            | SC detection threshold hysteresis                    | Charge and Discharge                                                                                                                      |                                                        | 40   | 50  | 60   | mV   |
| V <sub>(OL_acr)</sub>                           | OL detection threshold accuracy <sup>(1)</sup>       | Discharge                                                                                                                                 | V <sub>OL</sub> = 50 mV (min)                          | 40   | 50  | 60   | mV   |
|                                                 |                                                      |                                                                                                                                           | V <sub>OL</sub> = 100 mV                               | 90   | 100 | 110  |      |
|                                                 |                                                      |                                                                                                                                           | V <sub>OL</sub> = 205 mV (max)                         | 184  | 205 | 226  |      |
| V <sub>(SC_acr)</sub>                           | SC detection threshold accuracy <sup>(2)</sup>       | Charge and Discharge                                                                                                                      | V <sub>SC</sub> = 100 mV (min)                         | 80   | 100 | 120  | mV   |
|                                                 |                                                      |                                                                                                                                           | V <sub>SC</sub> = 200 mV                               | 180  | 200 | 220  |      |
|                                                 |                                                      |                                                                                                                                           | V <sub>SC</sub> = 475 mV (max)                         | 426  | 475 | 523  |      |
| FET DRIVE CIRCUIT                               |                                                      |                                                                                                                                           |                                                        |      |     |      |      |
| V <sub>(FETON)</sub>                            | Output voltage, charge and discharge FETs on         | V <sub>(FETOND)</sub> = V <sub>(BAT)</sub> − V <sub>(DSG)</sub><br>VGS connect 1 MΩ                                                       | BAT= 20 V                                              | 12   | 15  | 18   | V    |
|                                                 |                                                      | V <sub>(FETONC)</sub> =V <sub>(PACK)</sub> − V <sub>(CHG)</sub><br>VGS connect 1 MΩ                                                       | PACK= 20 V                                             | 12   | 15  | 18   |      |
| V <sub>(ZCHG)</sub>                             | ZVCHG clamp voltage                                  |                                                                                                                                           | PACK= 4.5 V                                            | 3.3  | 3.5 | 3.7  | V    |
| V <sub>(FETOFF)</sub>                           | Output voltage, charge and discharge FETs off        | V <sub>(FETOFF)</sub> = V <sub>(PACK)</sub> − V <sub>(DSG)</sub>                                                                          | PACK= 16 V                                             |      |     | 0.2  | V    |
|                                                 |                                                      | V <sub>(FETOFF)</sub> =V <sub>(BAT)</sub> − V <sub>(CHG)</sub>                                                                            | BAT = 16 V                                             |      |     | 0.2  |      |
| t <sub>r</sub>                                  | Rise time                                            | C <sub>L</sub> = 4700 pF                                                                                                                  | V <sub>DSG</sub> :10%–90%<br>V <sub>CHG</sub> :10%–90% |      | 40  | 200  | μs   |
| t <sub>f</sub>                                  | Fall time                                            | C <sub>L</sub> = 4700 pF                                                                                                                  | V <sub>DSG</sub> :90%–10%<br>V <sub>CHG</sub> :90%–10% |      | 40  | 200  |      |
| THERMISTOR DRIVE                                |                                                      |                                                                                                                                           |                                                        |      |     |      |      |
| r <sub>DS(on)</sub>                             | TOUT pass-element series resistance                  | I <sub>O</sub> = −1 mA at TOUT pin, r <sub>ds(ON)</sub> = (V <sub>REG</sub> − V <sub>O</sub> (TOUT))/1 mA, T <sub>A</sub> = −25°C to 85°C |                                                        |      | 50  | 100  | Ω    |
| LOGIC                                           |                                                      |                                                                                                                                           |                                                        |      |     |      |      |
| R <sub>(PUP)</sub>                              | Internal pullup resistance                           | XALERT                                                                                                                                    | T <sub>A</sub> = −25°C to 85°C                         | 60   | 100 | 200  | kΩ   |
|                                                 |                                                      | SDATA, SCLK,                                                                                                                              | T <sub>A</sub> = −25°C to 85°C                         | 6    | 10  | 20   |      |
| V <sub>OL</sub>                                 | Logic level output voltage                           | XALERT, I <sub>O</sub> = 200 μA,                                                                                                          | T <sub>A</sub> = −25°C to 85°C                         |      |     | 0.2  | V    |
|                                                 |                                                      | SDATA, I <sub>O</sub> = 50 μA,                                                                                                            | T <sub>A</sub> = −25°C to 85°C                         |      |     | 0.4  |      |
|                                                 |                                                      | OD I <sub>O</sub> = 1 mA,                                                                                                                 | T <sub>A</sub> = −25°C to 85°C                         |      |     | 0.6  |      |

(1) See OL register for setting detection threshold

(2) See SC register for setting detection threshold

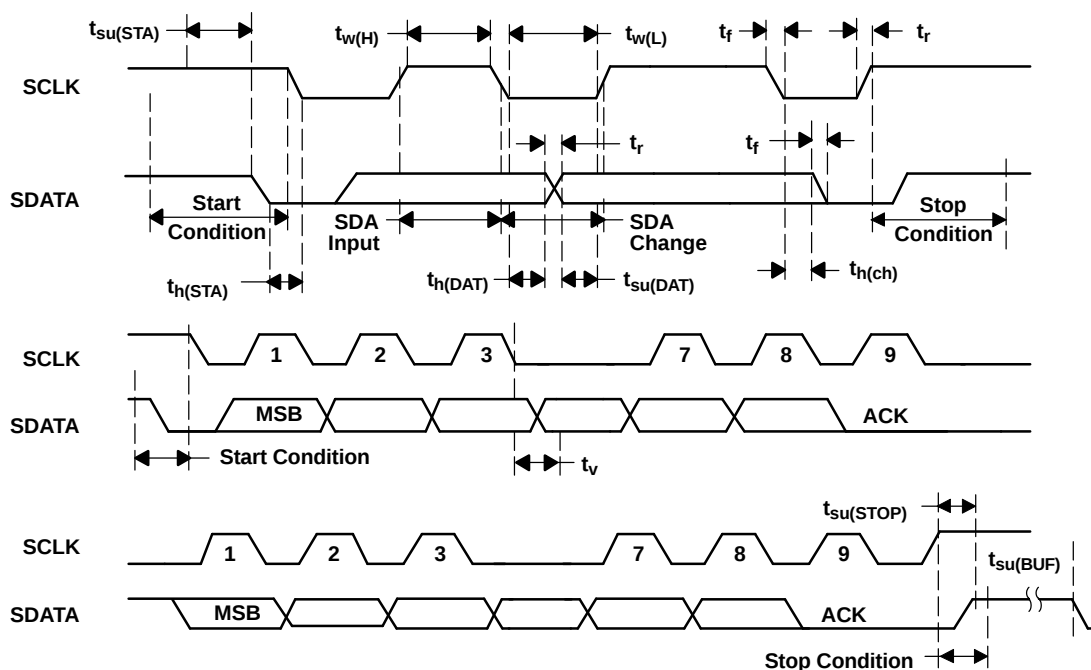
## AC ELECTRICAL CHARACTERISTICS

$T_A = 25^\circ\text{C}$ ,  $C_{(\text{REG})} = 4.7\ \mu\text{F}$ ,  $\text{BAT} = 14\ \text{V}$  (unless otherwise noted)

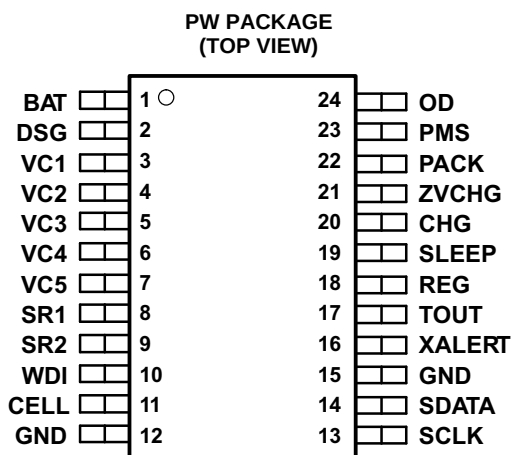
| PARAMETER             | TEST CONDITION           | MIN | NOM | MAX  | UNIT          |
|-----------------------|--------------------------|-----|-----|------|---------------|
| $t_{(\text{WDTINT})}$ | WDT start-up detect time | 250 | 700 | 2000 | ms            |
| $t_{(\text{WDWT})}$   | WDT detect time          |     | 100 |      | $\mu\text{s}$ |

## AC TIMING SPECIFICATIONS (I<sup>2</sup>C COMPATIBLE SERIAL INTERFACE)

| PARAMETER                    | MIN | MAX  | UNIT          |
|------------------------------|-----|------|---------------|
| $t_r$                        |     | 1000 | ns            |
| $t_f$                        |     | 300  | ns            |
| $t_{w(\text{H})}$            | 4.0 |      | $\mu\text{s}$ |
| $t_{w(\text{L})}$            | 4.7 |      | $\mu\text{s}$ |
| $t_{\text{su}(\text{STA})}$  | 4.7 |      | $\mu\text{s}$ |
| $t_{\text{h}(\text{STA})}$   | 4.0 |      | $\mu\text{s}$ |
| $t_{\text{su}(\text{DAT})}$  | 250 |      | ns            |
| $t_{\text{h}(\text{DAT})}$   | 0   |      | $\mu\text{s}$ |
| $t_{\text{su}(\text{STOP})}$ | 4.0 |      | $\mu\text{s}$ |
| $t_{\text{su}(\text{BUF})}$  | 4.7 |      | $\mu\text{s}$ |
| $t_v$                        |     | 900  | ns            |
| $t_{\text{h}(\text{CH})}$    | 0   |      | ns            |
| $f_{\text{SCL}}$             | 0   | 100  | kHz           |



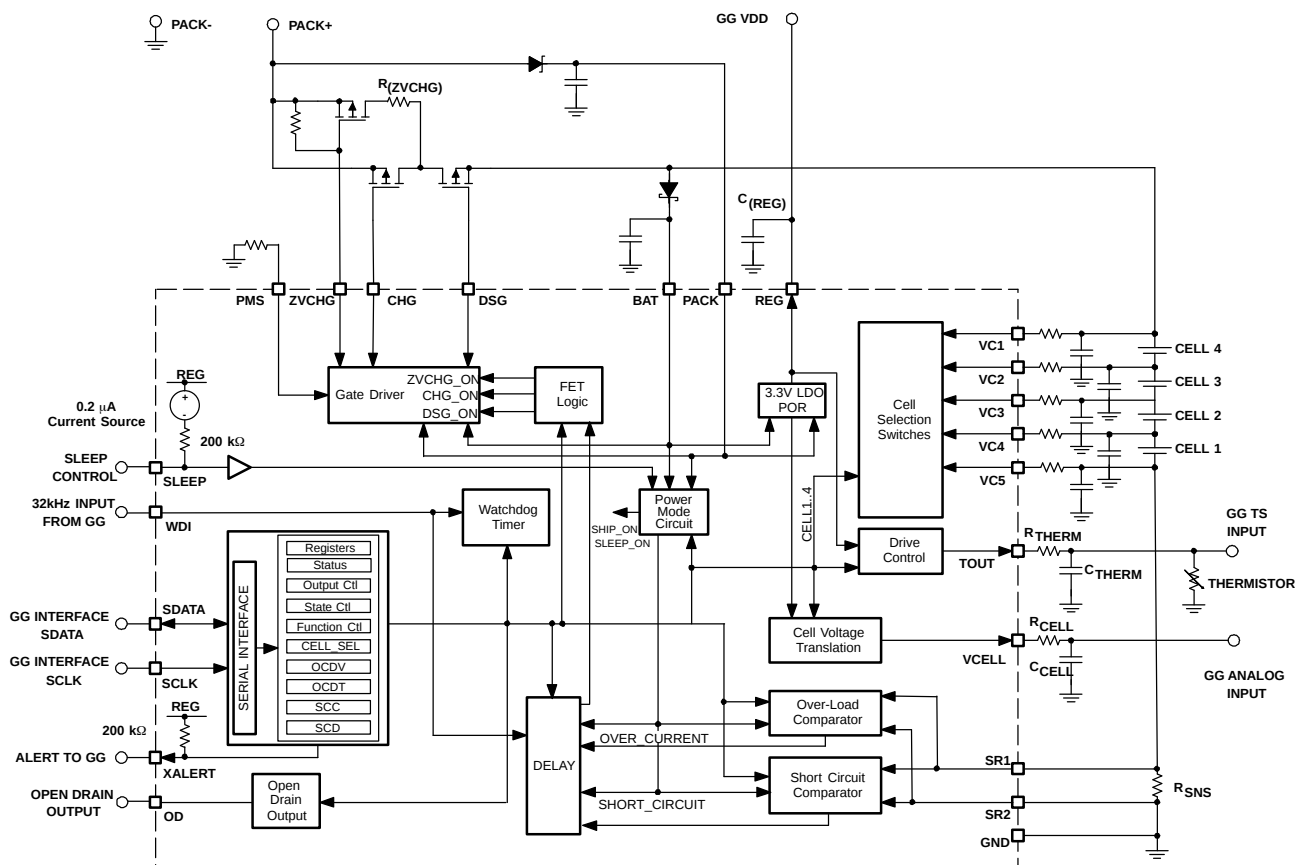
## PIN ASSIGNMENTS



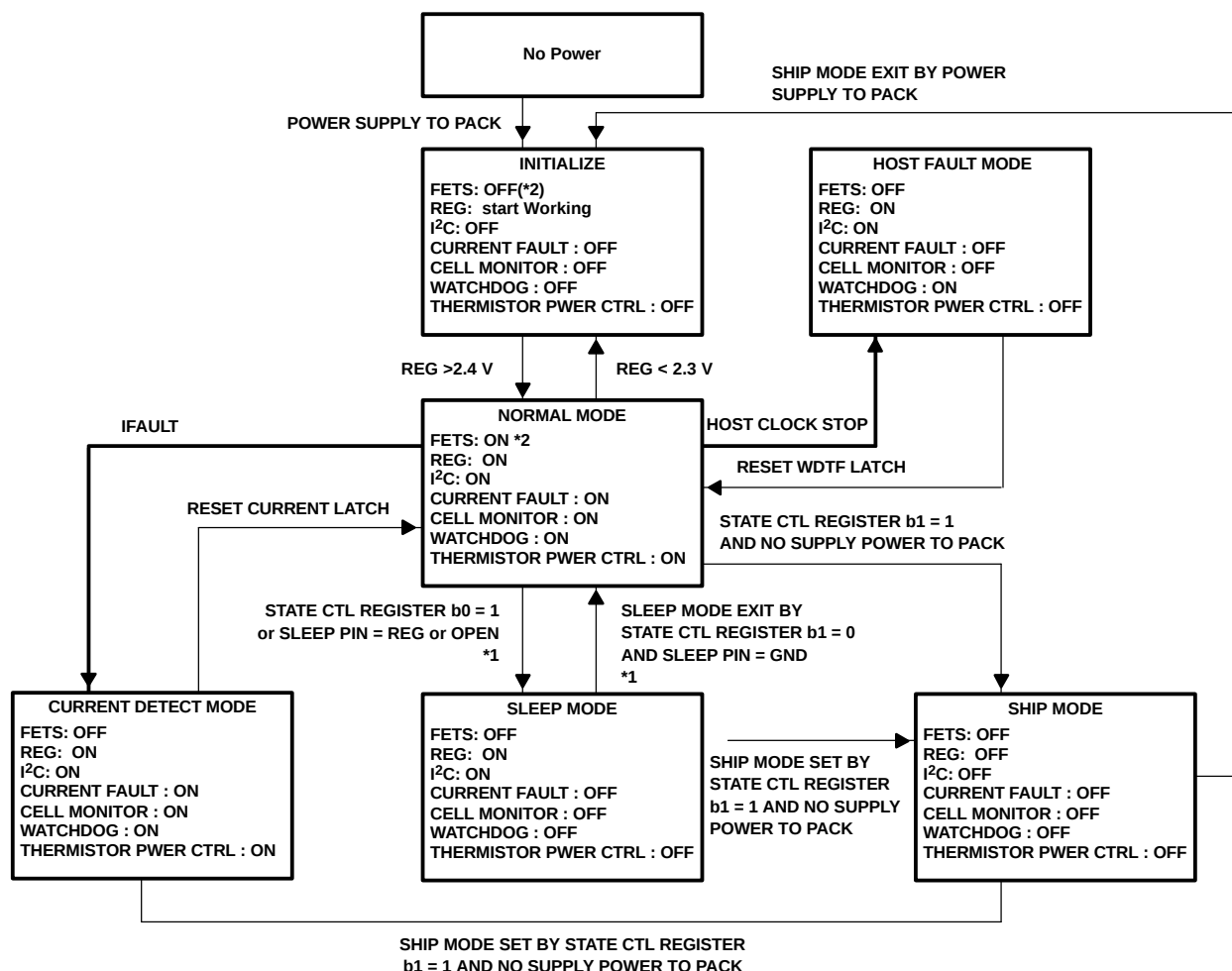
## Terminal Functions

| TERMINAL |     | DESCRIPTION                                                                                                                                                             |
|----------|-----|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME     | NO. |                                                                                                                                                                         |
| BAT      | 1   | Diode protected BAT+ terminal and primary power source.                                                                                                                 |
| DSG      | 2   | Push-pull output discharge FET gate drive                                                                                                                               |
| VC1      | 3   | Sense voltage input terminal for most positive cell and balance current input for most positive cell.                                                                   |
| VC2      | 4   | Sense voltage input terminal for second most positive cell, balance current input for second most positive cell and return balance current for most positive cell.      |
| VC3      | 5   | Sense voltage input terminal for third most positive cell, balance current input for third most positive cell and return balance current for second most positive cell. |
| VC4      | 6   | Sense voltage input terminal for least positive cell, balance current input for least positive cell and return balance current for third most positive cell.            |
| VC5      | 7   | Sense voltage input terminal for most negative cell, return balance current for least positive cell.                                                                    |
| SR1      | 8   | Current sense positive terminal when charging relative to SR2                                                                                                           |
| SR2      | 9   | Current sense negative terminal when discharging relative to SR2 current sense terminal                                                                                 |
| WDI      | 10  | Digital input that provides the timing clock for the OC and SC delays and also acts as the watchdog clock.                                                              |
| CELL     | 11  | Output of scaled value of the measured cell voltage.                                                                                                                    |
| GND      | 12  | Analog ground pin and negative pack terminal                                                                                                                            |
| SCLK     | 13  | Open-drain bidirectional serial interface clock with internal 10 k $\Omega$ pull-up to V <sub>(REG)</sub> .                                                             |
| SDATA    | 14  | Open-drain bidirectional serial interface data with internal 10 k $\Omega$ pull-up to V <sub>(REG)</sub> .                                                              |
| GND      | 15  | Connect to GND                                                                                                                                                          |
| XALERT   | 16  | Open-drain output used to indicate status register changes. With internal 100 k $\Omega$ pull-up to V <sub>(REG)</sub>                                                  |
| TOUT     | 17  | Provides thermistor bias current                                                                                                                                        |
| REG      | 18  | Integrated 3.3-V regulator output                                                                                                                                       |
| SLEEP    | 19  | This pin is pulled up to V <sub>(REG)</sub> internally, open or H level makes Sleep mode                                                                                |
| CHG      | 20  | Push-pull output charge FET gate drive                                                                                                                                  |
| ZVCHG    | 21  | The ZVCHG FET drive is connected here                                                                                                                                   |
| PACK     | 22  | PACK positive terminal and alternative power source                                                                                                                     |
| PMS      | 23  | 0-V charge configuration select pin, CHG terminal ON/OFF is determined by this pin.                                                                                     |
| OD       | 24  | NCH FET open drain output                                                                                                                                               |

## FUNCTIONAL BLOCK DIAGRAM



## STATE DIAGRAM



Interrupt Request When  
Entering These States

\*1: Interrupt Request is Granted When Only External Sleep Pin Changes

\*2: When PMS connect to Pack, Default State of CHG FET is ON.

## FUNCTIONAL DESCRIPTION

### Low-Dropout Regulator (REG)

The inputs for this regulator can be derived from the battery cell stack (BAT) or the pack positive terminal (PACK). The output is typically 3.3 V with the minimum output capacitance for stable operation is 4.7  $\mu$ F and is also internally current limited. During normal operation, the regulator limits output current to typically 50 mA.

### Initialization

The bq29312 internal control circuit is powered by the REG voltage, which it also monitors. When the voltage at REG falls below 2.3 V, the internal circuit turns off the FETs and disables all controllable functions, including the REG and TOUT outputs. REG does not start up unless a voltage above  $V_{(STARTUP)}$  is supplied to the PACK terminal. After the regulator has started, based on PACK voltage, it keeps operating through the BAT input, even if the PACK voltage is removed. If the BAT input is below the minimum operating range, then the bq29312 does not operate if the supply to the PACK input is removed. After start up, when the REG voltage is above 2.4 V, the bq29312 is in Normal mode.

The initial state of the CHG output depends on the PMS input. If PMS = PACK then CHG = ON however, if PMS = GND then CHG = OFF.

### Overload Detection

The overload detection is used to detect abnormal currents in the discharge direction. This feature is used to protect the pass FETs, cells and any other inline components from excessive current conditions. The detection circuit also incorporates a blanking delay before driving the control for the pass FETs to the OFF state. The overload sense voltage is set in the OLV register, and delay time is set in the OLT register. The overload threshold can be programmed from 50 mV to 205 mV in 5-mV steps with the default being 50 mV and hysteresis of 10 mV.

### Short-Circuit Detection

The short current circuit detection is used to detect abnormal current in either the charge or discharge direction. This safety feature is used to protect the pass FETs, cells, and any other inline components from excessive current conditions. The detection circuit also incorporates a blanking delay before driving the control for the pass FETs to the OFF state. The short-circuit thresholds and delay time are set in the SCC and SCD registers respectively where SCC is for charging and SCD is for discharge. The short-circuit threshold can be programmed from 100 mV to 475 mV in 25-mV steps with the default being 100 mV and hysteresis of 50 mV.

### Overload and Short-Circuit Delay

The overload delay (default = 1 ms) allows the system to momentarily accept a high current condition without disconnecting the supply to the load. The delay time can be increased via the OLT register, which can be programmed for a range of 1 ms to 31 ms with steps of 2 ms.

The short-circuit delay (default = 0  $\mu$ s) is programmable in the SCC and SCD registers. This register can be programmed from 0  $\mu$ s to 915  $\mu$ s with steps of 61  $\mu$ s.

### Overload and Short-Circuit Response

When an overload or short-circuit fault is detected, the FETs are turned off. The STATUS (b0...b2) register reports the details of short-circuit (charge), short-circuit (discharge), and overload. The respective STATUS (b0...b2) bits are set to 1 and the XALERT output is triggered. This condition is latched until the CONTROL (b0) is set and then reset. If a FET is turned on via resetting CONTROL (b0) and the error condition is still present on the system, then the device reenters the protection response state.

## FUNCTIONAL DESCRIPTION (continued)

### Cell Voltage

The cell voltage is translated to allow a system host to measure individual series elements of the battery. The series element voltage is translated to a GND-based voltage equal to  $0.15 \pm 0.002$  of the series element voltage. This provides a range from 0 V to 4.5 V. The translation output is inversely proportional to the input using the following equation.

$$\text{Where, } V_{(\text{CELL OUT})} = -K \times V_{(\text{CELL IN})} + 0.975 \text{ (V)}$$

Programming CELL\_SEL (b1, b0) selects the individual series element. The CELL\_SEL (b3, b2) selects the voltage monitor mode, cell monitor, offset etc.

### Calibration of Cell Voltage Monitor Amplifier Gain

The cell voltage monitor amplifier has an offset and to increase accuracy this can be calibrated.

There are a couple of method by calibration circumstance.

The following procedure shows how to measure and calculate the offset and gain as one of example.

- **Step 1**
  - Set CAL1=1, CAL0=1, CELL1=0, CELL0=0, VMEN=1
  - $V_{\text{REF}}$  is trimmed to 0.975 V within  $\pm 1\%$ , measuring  $V_{\text{REF}}$  eliminates its error.
  - Measure internal reference voltage  $V_{\text{REF}}$  from VCELL directly.
  - $V_{\text{REF}}$ =measured reference voltage
- **Step 2**
  - Set CAL1=0, CAL0=0, CELL1=0, CELL0=0, VMEN=1
  - The output voltage includes the offset and represented by:  

$$V_{\text{O(4-5)}} = V_{\text{REF}} + (1 + K) \times V_{\text{OS}} \text{ (V)}$$
 Where K = CELL Scaling Factor
  - $V_{\text{OS}}$  = Offset voltage at input of the internal operational-amplifier
- **Step 3**
  - Set CAL1=1, CAL0=0, CELL1=0, CELL0=0, VMEN=1
  - Measuring scaled REF voltage through VCELL amp.
  - The output voltage includes the scale factor error and offset and is represented by:  

$$V_{(\text{OUTR})} = V_{\text{REF}} + (1 + K) \times V_{\text{OS}} - K \times V_{\text{REF}} \text{ (V)}$$
- **Step 4**
  - Calculate  $(V_{\text{O(4-5)}} - V_{(\text{OUTR})})/V_{\text{REF}}$
  - The result is the actual scaling factor,  $K_{(\text{ACT})}$  and is represented by:  

$$K_{(\text{ACT})} = (V_{\text{O(4-5)}} - V_{(\text{OUTR})})/V_{\text{REF}} = (V_{\text{REF}} + (1 + K) \times V_{\text{OS}}) - (V_{\text{REF}} + (1 + K) \times V_{\text{OS}} - K \times V_{\text{REF}})/V_{\text{REF}} = K \times V_{\text{REF}}/V_{\text{REF}} = K$$
- **Step 5**
  - Calculate the actual offset value where:  

$$V_{\text{OS(ACT)}} = (V_{\text{O(4-5)}} - V_{\text{REF}})/(1 + K_{(\text{ACT})})$$
- **Step 6**
  - Calibrated cell voltage is calculated by:  

$$V_{\text{Cn}} - V_{\text{C(n+1)}} = \{V_{\text{REF}} + (1 + K_{(\text{ACT})}) \times V_{\text{OS(ACT)}} - V_{(\text{CELLOUT})}\}/K_{(\text{ACT})} - \{V_{\text{O(4-5)}} - V_{(\text{CELLOUT})}\}/K_{(\text{ACT})}$$

## FUNCTIONAL DESCRIPTION (continued)

For improved measurement accuracy,  $V_{OS(ACT)}$  for each cell voltage should be measured.

- Set CAL1=0, CAL0=0, CELL1=0, CELL0=1, VMEN=1
- Set CAL1=0, CAL0=0, CELL1=1, CELL0=0, VMEN=1
- Set CAL1=0, CAL0=0, CELL1=1, CELL0=1, VMEN=1

Measuring  $V_{O(3-4)}$ ,  $V_{O(2-3)}$ ,  $V_{O(1-2)}$ ,

- $VC4 - VC5 = \{V_{O(4-5)} - V_{(CELLOUT)}\} / K_{(ACT)}$
- $VC3 - VC4 = \{V_{O(3-4)} - V_{(CELLOUT)}\} / K_{(ACT)}$
- $VC2 - VC3 = \{V_{O(2-3)} - V_{(CELLOUT)}\} / K_{(ACT)}$
- $VC1 - VC2 = \{V_{O(1-2)} - V_{(CELLOUT)}\} / K_{(ACT)}$

## Cell Balance Control

The cell balance control allows a small bypass path to be controlled for any one series element. The purpose of this bypass path is to reduce the current into any one cell during charging to bring the series elements to the same voltage. Series resistors placed between the input pins and the positive series element nodes control the bypass current value. Individual series element selection is made using bits 4 through 7 of the CELL\_SEL register.

## Thermistor Drive Circuit (TOUT)

The TOUT pin can be enabled to drive a thermistor from REG. The typical thermistor resistance is 10 k $\Omega$  at 25°C. The default-state is OFF to conserve power. The maximum output impedance is 100  $\Omega$ . TOUT is enabled in FUNCTION CTL Register (bit 5).

## Open Drain Drive Circuit (OD)

The open drain output has 1-mA current source drive with a maximum output voltage of 25 V. The OD output is enabled or disabled by OUTPUT CTL Register (bit 4) and has a default state of OFF.

## XALERT (XALERT)

XALERT is driven low when an OL or SC current fault is detected, if the SLEEP pin changes state or a watchdog fault occurs. To clear XALERT, toggle (from 0, set to 1 then reset to 0) OUTPUT CTL (bit 0), then read the STATUS register.

## Latch Clear (LTCLR)

When a current limit fault or watch dog timer fault occurs, the state is latched. To clear these faults, toggle (from 0, set 1 then reset to 0) LTCLR in the OUTPUT CTL register (bit 0).

Figure 1 is the LTCLR and XALERT clear example after sensing short-circuit.

## FUNCTIONAL DESCRIPTION (continued)

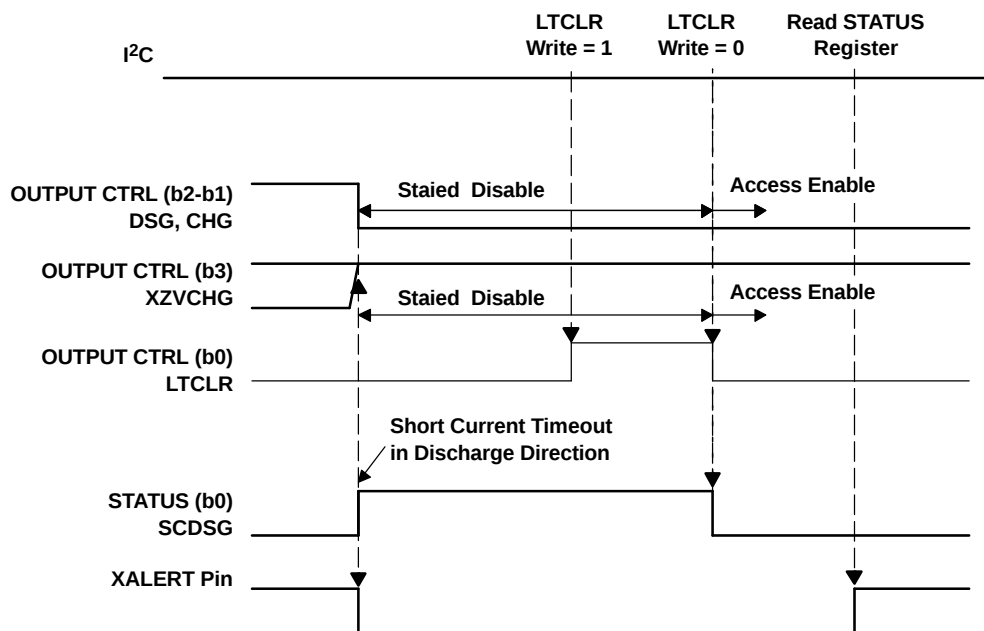


Figure 1. LTCLR and XALERT Clear Example After Sensing Short LTCLR and XALER Clear Example

## 2-, 3-, or 4-Cell Configuration

In a 3-cell configuration, VC1 is shorted to VC2. In a 2-cell configuration, VC1 and VC2 are shorted to VC3.

## FUNCTIONAL DESCRIPTION (continued)

### Watchdog Input (WDI)

The WDI input is required as a time base for delay timing when determining overload and short-circuit delay periods and is used as part of the system watchdog.

Initially the watchdog monitors the hosts oscillator start up, if there is no response from the host within 700 ms of the bq29312 reaching its minimum operating voltage, then the bq29312 turns both CHG, DSG and ZVCHG FETs OFF.

Once the watchdog has been started during this wake up period, it monitors the host for an oscillation stop condition, which is defined as a period of 100  $\mu$ s (typ) where no clock input is received. If an oscillator stop condition is identified, then the watchdog turns the CHG, DSG and ZVCHG FETs OFF. When the host clock oscillation is started, WDF is released, but the flag is latched until LTCLR is toggled.

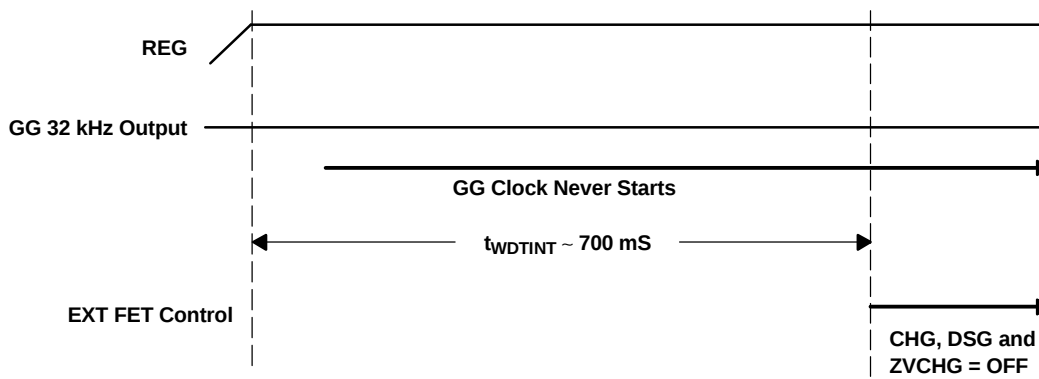


Figure 2. Watchdog Timing Chart—WDI Fault at Startup

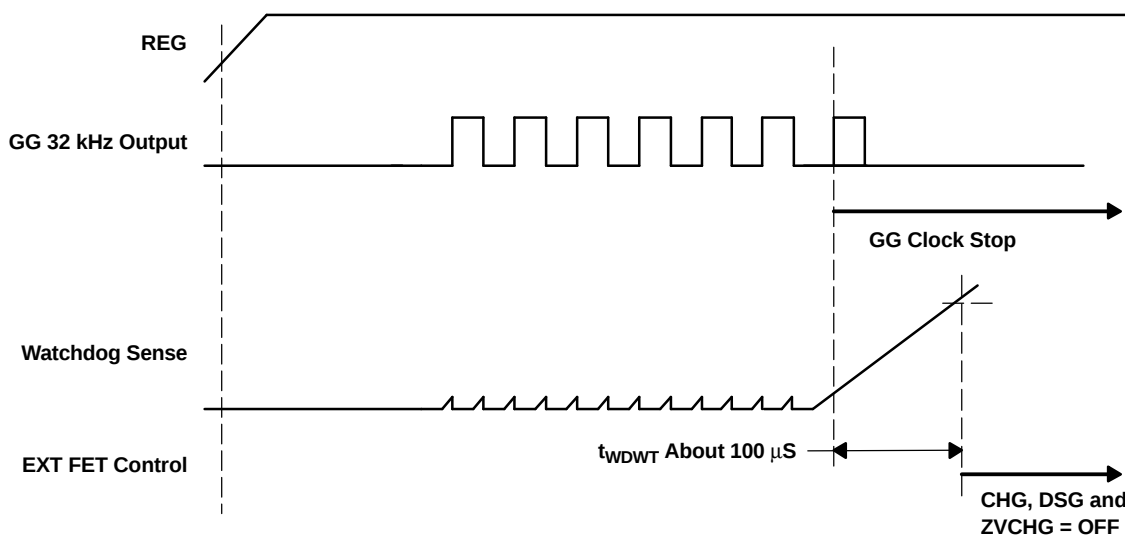


Figure 3. Watchdog Timing Chart—WDI Fault After Startup

### DSG and CHG FET Driver Control

The bq29312 drives the DSG, CHG, and ZVCHG FET off if an OL or SC safety threshold is breached depending on the current direction. The host can force any FET on or off only if the bq29312 integrated protection control allows. The DSG and CHG FET drive gate-to-drain voltage is clamped to 15 V (typ).

## FUNCTIONAL DESCRIPTION (continued)

The default-state of the CHG and DSG FET drive is off, when PMS = GND. A host can control the FET drive by programming OUTPUT CTL (b3...b1) where b1 is used to control the discharge FET, b2 is used to control the charge FET and b3 is used to control the ZVCHG FET. These controls are only valid when not in the initialized state. The CHG drive FET can be powered by PACK and the DSG FET can be powered by BAT.

## Precharge and 0 V Charging—Theory of Operation

The bq29312 supports both a charger that has a precharge mode and one that does not. The bq29312 also supports charging even when the battery falls to 0 V. Detail is described in the application section.

## SLEEP Control Input (SLEEP)

The SLEEP input is pulled-up internally to REG. When SLEEP is pulled to REG, the bq29312 enters the SLEEP mode. The SLEEP mode disables all the FET outputs and the OL, SC and watchdog faults are also disabled. The RAM configuration is still valid on exit of the SLEEP mode. The host can force the bq29312 into SLEEP mode via register control also.

**Table 1. SLEEP Control Input**

| ITEM                                               | SLEEP    |                                             | EXIT SLEEP                                                                                         |
|----------------------------------------------------|----------|---------------------------------------------|----------------------------------------------------------------------------------------------------|
|                                                    | FUNCTION | I <sup>2</sup> C READ/WRITE                 |                                                                                                    |
| I <sup>2</sup> C Read/Write                        | Active   | Write is available,<br>but read is disabled | Last pre-sleep entry configuration is valid.(If change configuration, latest write data is valid.) |
| REG Output                                         | Active   |                                             |                                                                                                    |
| External pin control:<br>CHG, DSG, ZVCHG, TOUT, OD | Disabled |                                             |                                                                                                    |
| OC and SC protection:<br>SCD, SCC and OCD          |          |                                             |                                                                                                    |
| CELL Translation<br>PACKOUT, VMEN                  |          |                                             |                                                                                                    |
| Cell Balancing:<br>CB[3:0]                         |          |                                             |                                                                                                    |
| Watchdog: WDDIS                                    |          |                                             |                                                                                                    |

## Power Modes

The bq29312 has three power modes, Normal, Sleep, and Ship. The following table outlines the operational functions during these power modes.

**Table 2. Power Modes**

| POWER MODE | TO ENTER POWER MODE                                                          | TO EXIT POWER MODE                    | MODE DESCRIPTION                                                                                                                                                                                                                                                                         |
|------------|------------------------------------------------------------------------------|---------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Normal     | SLEEP = GND and<br>STATE CTL( b0) = 0 and<br>STATE CTL( b1) = 0              |                                       | The battery is in normal operation with protection, power management and battery monitoring functions available and operating.<br><br>The supply current of this mode varies as the host can enable and disable various power management features.                                       |
| Sleep      | {SLEEP = REG (floating) or<br>STATE CTL( b0) = 1 } and<br>STATE CTL( b1) = 0 | SLEEP = GND and<br>STATE CTL( b0) = 0 | All functions stop except LDO and I <sup>2</sup> C interface.<br>On entry to this mode, all registers are masked off keeping their state.<br>The host controller can change the RAM registers via the I <sup>2</sup> C interface, but reading data is disabled until exit of Sleep mode. |
| Ship       | STATE CTL( b1) = 1<br>And supply at the PACK pin is removed                  | Supply voltage to PACK                | The bq29312 is completely shut down as in the sleep mode. In addition the REG output is disabled, I <sup>2</sup> C interface is powered down and memory is not valid.                                                                                                                    |

## Communications

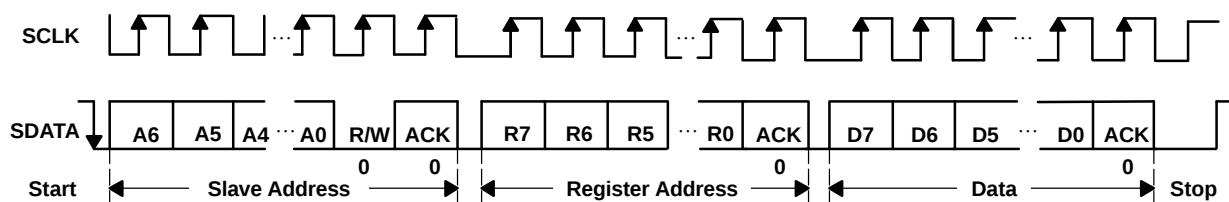
The I<sup>2</sup>C compatible serial communications provides read and write access to the bq29312 data area. The data is clocked via separate data (SDATA) and clock (SCLK) pins. The bq29312 acts as a slave device and does not generate clock pulses. Communication to the bq29312 is provided from GPIO pins or an I<sup>2</sup>C supporting port of a host system controller. The slave address for the bq29312 is 7 bits and the value is 0100 000 (0x20).

|                      | I <sup>2</sup> C ADDRESS +R/W BIT |   |   |   |   |   |   | (LSB) |
|----------------------|-----------------------------------|---|---|---|---|---|---|-------|
|                      | I <sup>2</sup> C ADDRESS (0x20)   |   |   |   |   |   |   | (LSB) |
| Write <sup>(1)</sup> | 0                                 | 1 | 0 | 0 | 0 | 0 | 0 | 0     |
| Read                 | 0                                 | 1 | 0 | 0 | 0 | 0 | 0 | 1     |

(1) Bit 0: 0 = write, 1 = read

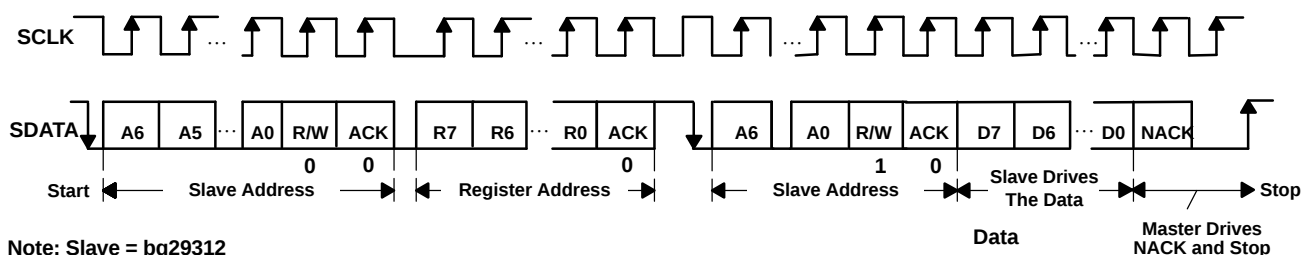
The bq29312 does *not* have the following functions compatible with the I<sup>2</sup>C specification.

- The bq29312 is always regarded as a slave.
- The bq29312 does not return a NACK for an invalid register address.
- The bq29312 does not support the general code of the I<sup>2</sup>C specification, and therefore does not return an ACK.
- The bq29312 does *not* support the address auto increment, which allows continuous reading and writing.
- The bq29312 allows data to be written or read from the same location without resending the location address.



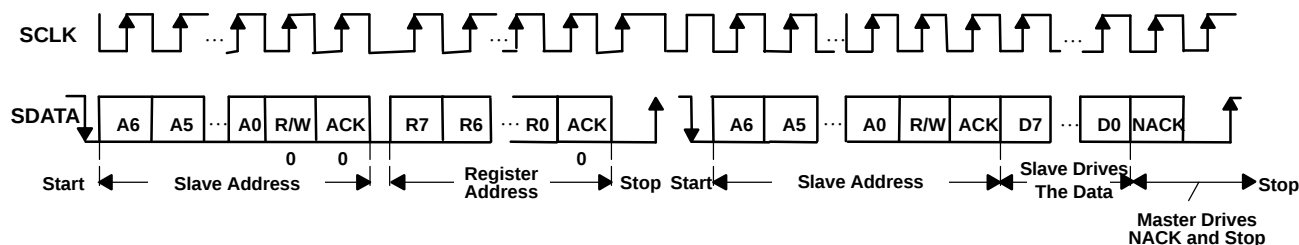
Note: Slave = bq29312

Figure 4. I<sup>2</sup>C-Bus Write to bq29312



Note: Slave = bq29312

Figure 5. I<sup>2</sup>C-Bus Read from bq29312: Protocol A



Note: Slave = bq29312

Figure 6. I<sup>2</sup>C-Bus Read from bq29312: Protocol B

## Register Map

The bq29312 has 9 addressable registers. These registers provide status, control, and configuration information for the battery protection system.

**Table 3. Addressable Registers**

| NAME         | ADDR | TYPE | DESCRIPTION                                                                                 |
|--------------|------|------|---------------------------------------------------------------------------------------------|
| STATUS       | 0x00 | R    | Status register                                                                             |
| OUTPUT CTL   | 0x01 | R/W  | Output pin control from system host                                                         |
| STATE CTL    | 0x02 | R/W  | State control                                                                               |
| FUNCTION CTL | 0x03 | R/W  | Function control                                                                            |
| CELL_SEL     | 0x04 | R/W  | Battery cell select for cell translation and balance bypass and select mode for calibration |
| OLV          | 0x05 | R/W  | Overload threshold voltage                                                                  |
| OLT          | 0x06 | R/W  | Overload delay time                                                                         |
| SCC          | 0x07 | R/W  | Short-circuit current threshold voltage and delay for charge                                |
| SCD          | 0x08 | R/W  | Short-circuit current threshold voltage and delay for discharge                             |

## STATUS : Status register

| STATUS REGISTER (0x00) |   |        |          |     |    |       |       |
|------------------------|---|--------|----------|-----|----|-------|-------|
| 7                      | 6 | 5      | 4        | 3   | 2  | 1     | 0     |
| 0                      | 0 | ZVCLMP | SLEEPDET | WDF | OL | SCCHG | SCDSG |

The STATUS register provides information about the current state of the bq29312. Reading the STATUS register clears the XALERT pin.

STATUS b0 (SCDSG): This bit indicates a short-circuit in the discharge direction.

0 = Current below the short-circuit threshold in the discharge direction (default).

1 = Current greater than or equal to the short-circuit threshold in the discharge direction.

STATUS b1 (SCCHG): This bit indicates a short-circuit in the charge direction.

0 = Current below the short-circuit threshold in the charge direction (default).

1 = Current greater than or equal to the short-circuit threshold in the charge direction.

STATUS b2 (OL): This bit indicates an overload condition.

0 = Current less than or equal to the overload threshold (default).

1 = Current greater than overload threshold.

STATUS b3 (WDF): This bit indicates a watchdog fault condition has occurred.

0 = 32 kHz oscillation is normal (default).

1 = 32 kHz oscillation stopped or not started and the watchdog has timed out.

STATUS b4 (SLEEPDET): This bit indicates the bq29312 is SLEEP mode.

0 = bq29312 is not SLEEP mode (default).

1 = bq29312 is SLEEP mode.

STATUS b5 (ZVCLMP): This bit indicates ZVCHG output is clamped.

0 = ZVCHG pin is not clamped (default).

1 = ZVCHG pin is clamped.

## OUTPUT CTL: Output Control Register

| OUTPUT CTL REGISTER (0x01) |   |   |    |        |     |     |       |
|----------------------------|---|---|----|--------|-----|-----|-------|
| 7                          | 6 | 5 | 4  | 3      | 2   | 1   | 0     |
| 0                          | 0 | 0 | OD | XZVCHG | CHG | DSG | LTCLR |

The OUTPUT CTL register controls the outputs of the bq29312 and can be used to clear certain states.

**OUTPUT CTL b0 (LTCLR):** When a current limit fault or watchdog timer fault is latched, this bit releases the fault latch when toggled from 0 to 1 and back to 0 (default =0).

0 = (default)

0->1 ->0 clears the fault latches

**OUTPUT CTL b1 (DSG):** This bit controls the external discharge FET.

0 = discharge FET is off and is controlled by the system host (default).

1 = discharge FET is on and the bq29312 is in normal operating mode.

**OUTPUT CTL b2 (CHG):** This bit controls the external charge FET.

**PMS=GND**

0 = charge FET is off and is controlled by the system host (default).

1 = charge FET is on and the bq29312 is in normal operating mode.

**PMS=PACK**

0 = charge FET is off and is controlled by the system host.

1 = charge FET is on and the bq29312 is in normal operating mode (default).

**OUTPUT CTL b3 (XZVCHG):** This bit controls the external ZVCHG FET.

0 = ZVCHG FET is on and is controlled by the system host (default).

1 = ZVCHG FET is off and the bq29312 is in normal operating mode.

**OUTPUT CTL b4 (OD):** This bit enables or disables the OD output.

0 = OD is high impedance (default).

1 = OD output is active (GND).

## STATE CTL: State Control Register

| STATE CTL REGISTER (0x02) |   |   |   |   |       |      |       |
|---------------------------|---|---|---|---|-------|------|-------|
| 7                         | 6 | 5 | 4 | 3 | 2     | 1    | 0     |
| 0                         | 0 | 0 | 0 | 0 | WDDIS | SHIP | SLEEP |

The STATE CTL register controls the state of the bq29312.

**STATE CTL b0 (SLEEP):** This bit is used to enter the sleep power mode.

0 = bq29312 exits sleep mode (default).

1 = bq29312 enters the sleep mode.

**STATE CTL b1 (SHIP):** This bit is used to enter the ship power mode when pack supply voltage is not applied.

0 = bq29312 in normal mode (default).

1 = bq29312 enters ship mode when pack voltage is removed.

**STATE CTL b2 (WDDIS):** This bit is used to enable or disable the watchdog timer function.

0 = enable clock monitoring (default).

1 = disable clock monitoring.

**NOTE:** Use caution when setting the WDDIS. For example, when the 32-kHz input fails, the overload and short-circuit delay timers no longer function because they use the same WDI input. If the WDI input clock stops, these current protections do not function. WDF should be enabled at any time for maximum safety. If the watchdog function is disabled, the CHG and DSG FETs should be turned off.

## FUNCTION CTL: Function Control Register

| FUNCTION CTL REGISTER (0x03) |   |      |      |      |     |         |      |
|------------------------------|---|------|------|------|-----|---------|------|
| 7                            | 6 | 5    | 4    | 3    | 2   | 1       | 0    |
| 0                            | 0 | TOUT | XSCD | SSCC | XOL | PACKOUT | VMEN |

The FUNCTION CTL register enables and disables functions of the bq29312.

FUNCTION CTL b0 (VMEN): This bit enables or disables the cell and battery voltage monitoring function.

0 = disable voltage monitoring (default). CELL output is pulled down to GND level.

1 = enable voltage monitoring.

FUNCTION CTL b1 (PACKOUT): This bit is used to translate the PACK input to the CELL pin when VMEN=1. The pack voltage is divided by 25 and is presented on CELL regardless of the CELL\_SEL register settings.

0 = disable PACK OUT (default).

1 = enable PACK OUT.

FUNCTION CTL b2 (XOL): This bit enables or disables the over current sense function.

0 = enable over load sense (default).

1 = disable over load sense.

FUNCTION CTL b3 (XSCC): This bit enables or disables the short current sense function of charging.

0 = enable short-circuit current sense in charge direction (default).

1 = disable short-circuit current sense in charge direction.

FUNCTION CTL b4 (XSCD): This bit enables or disables the short current sense function of discharge.

0 = enable short-circuit current sense in discharge direction (default).

1 = disable short-circuit current sense in discharge direction.

FUNCTION CTL b5 (TOUT): This bit controls the power to the thermistor.

0 = thermistor power is off (default).

1 = thermistor power is on.

**CELL\_SEL: Cell Select Register**

| CELL_SEL REGISTER (0x04) |     |     |     |      |      |       |       |
|--------------------------|-----|-----|-----|------|------|-------|-------|
| 7                        | 6   | 5   | 4   | 3    | 2    | 1     | 0     |
| CB3                      | CB2 | CB1 | CB0 | CAL1 | CAL0 | CELL1 | CELL0 |

This register determines cell selection for voltage measurement and translation, cell balancing and the operational mode of the cell voltage monitoring.

CELL\_SEL b0–b1 (CELL0–CELL1): These two bits select the series cell for voltage measurement translation.

| CELL1 | CELL0 | SELECTED CELL                            |
|-------|-------|------------------------------------------|
| 0     | 0     | VC4–VC5, Bottom series element (Default) |
| 0     | 1     | VC4–VC3, Second lowest series element    |
| 1     | 0     | VC3–VC2, Second highest series element   |
| 1     | 1     | VC1–VC2, Top series element              |

CELL\_SEL b2–b3 (CAL1, CAL0): These bits determine the mode of the voltage monitor block.

| CAL1 | CAL0 | SELECTED MODE                                                                                |
|------|------|----------------------------------------------------------------------------------------------|
| 0    | 0    | Cell translation for selected cell (default)                                                 |
| 0    | 1    | Offset measurement for selected cell                                                         |
| 1    | 0    | Monitor the $V_{REF}$ value for gain calibration                                             |
| 1    | 1    | Monitor the $V_{REF}$ directly value for gain calibration, bypassing the translation circuit |

CELL\_SEL b4–b7 (CB0–CB3): These 4 bits select the series cell for cell balance bypass path.

CELL\_SEL b4 (CB0): This bit enables or disables the bottom series cell balance charge bypass path

0 = disable bottom series cell balance charge bypass path (default).

1 = enable bottom series cell balance charge bypass path.

CELL\_SEL b5 (CB1): This bit enables or disables the second lowest series cell balance charge bypass path.

0 = disable series cell balance charge bypass path (default).

1 = enable series cell balance charge bypass path.

CELL\_SEL b6 (CB2): This bit enables or disables the second highest cell balance charge bypass path.

0 = disable series cell balance charge bypass path (default).

1 = enable series cell balance charge bypass path.

CELL\_SEL b7 (CB3): This bit enables or disables the highest series cell balance charge bypass path.

0 = disable series cell balance charge bypass path (default).

1 = enable series cell balance charge bypass path.

## OLV: Overload Voltage Threshold Register

| OLV REGISTER (0x05) |   |   |      |      |      |      |      |
|---------------------|---|---|------|------|------|------|------|
| 7                   | 6 | 5 | 4    | 3    | 2    | 1    | 0    |
| 0                   | 0 | 0 | OLV4 | OLV3 | OLV2 | OLV1 | OLV0 |

OLV (b4–b0): These five bits select the value of the over load threshold with a default of 00000.

OLV (b4–b0) configuration bits with corresponding voltage threshold

|       |         |       |         |       |         |       |         |
|-------|---------|-------|---------|-------|---------|-------|---------|
| 00000 | 0.050 V | 01000 | 0.090 V | 10000 | 0.130 V | 11000 | 0.170 V |
| 00001 | 0.055 V | 01001 | 0.095 V | 10001 | 0.135 V | 11001 | 0.175 V |
| 00010 | 0.060 V | 01010 | 0.100 V | 10010 | 0.140 V | 11010 | 0.180 V |
| 00011 | 0.065 V | 01011 | 0.105 V | 10011 | 0.145 V | 11011 | 0.185 V |
| 00100 | 0.070 V | 01100 | 0.110 V | 10100 | 0.150 V | 11100 | 0.190 V |
| 00101 | 0.075 V | 01101 | 0.115 V | 10101 | 0.155 V | 11101 | 0.195 V |
| 00110 | 0.080 V | 01110 | 0.120 V | 10110 | 0.160 V | 11110 | 0.200 V |
| 00111 | 0.085 V | 01111 | 0.125 V | 10111 | 0.165 V | 11111 | 0.205 V |

## OLT: Overload Blanking Delay Time Register

| OLT REGISTER (0x06) |   |   |   |      |      |      |      |
|---------------------|---|---|---|------|------|------|------|
| 7                   | 6 | 5 | 4 | 3    | 2    | 1    | 0    |
| 0                   | 0 | 0 | 0 | OLT3 | OLT2 | OLT1 | OLT0 |

OLT(b3–b0): These four bits select the value of the delay time for overload with a default of 0000.

OLT(b3–b0) configuration bits with corresponding delay time

|      |      |      |       |      |       |      |       |
|------|------|------|-------|------|-------|------|-------|
| 0000 | 1 ms | 0100 | 9 ms  | 1000 | 17 ms | 1100 | 25 ms |
| 0001 | 3 ms | 0101 | 11 ms | 1001 | 19 ms | 1101 | 27 ms |
| 0010 | 5 ms | 0110 | 13 ms | 1010 | 21 ms | 1110 | 29 ms |
| 0011 | 7 ms | 0111 | 15 ms | 1011 | 23 ms | 1111 | 31 ms |

## SCC: Short Circuit in Charge Configuration Register

| SCC REGISTER (0x07) |       |       |       |       |       |       |       |
|---------------------|-------|-------|-------|-------|-------|-------|-------|
| 7                   | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| SCCT3               | SCCT2 | SCCT1 | SCCT0 | SCCV3 | SCCV2 | SCCV1 | SCCV0 |

This register selects the short-circuit threshold voltage and delay for charge.

SCC(b3–b0) : These bits select the value of the short-circuit voltage threshold with 0000 as the default.

SCC(b3–b0) with corresponding SC threshold voltage

|      |         |      |         |      |         |      |         |
|------|---------|------|---------|------|---------|------|---------|
| 0000 | 0.100 V | 0100 | 0.200 V | 1000 | 0.300 V | 1100 | 0.400 V |
| 0001 | 0.125 V | 0101 | 0.225 V | 1001 | 0.325 V | 1101 | 0.425 V |
| 0010 | 0.150 V | 0110 | 0.250 V | 1010 | 0.350 V | 1110 | 0.450 V |
| 0011 | 0.175 V | 0111 | 0.275 V | 1011 | 0.375 V | 1111 | 0.475 V |

SCC(b7–b4): These bits select the value of the short-circuit delay time. Exceeding the short-circuit voltage threshold for longer than this period will turn off the corresponding CHG, DSG, and ZVCHG output. 0000 is the default.

SCC(b7–b4) with corresponding SC delay time

|      |             |      |             |      |             |      |             |
|------|-------------|------|-------------|------|-------------|------|-------------|
| 0000 | 0 $\mu$ s   | 0100 | 244 $\mu$ s | 1000 | 488 $\mu$ s | 1100 | 732 $\mu$ s |
| 0001 | 61 $\mu$ s  | 0101 | 305 $\mu$ s | 1001 | 549 $\mu$ s | 1101 | 793 $\mu$ s |
| 0010 | 122 $\mu$ s | 0110 | 366 $\mu$ s | 1010 | 610 $\mu$ s | 1110 | 854 $\mu$ s |
| 0011 | 183 $\mu$ s | 0111 | 427 $\mu$ s | 1011 | 671 $\mu$ s | 1111 | 915 $\mu$ s |

### SCD: Short Circuit in Discharge Configuration Register

| SCD REGISTER (0x08) |       |       |       |       |       |       |       |
|---------------------|-------|-------|-------|-------|-------|-------|-------|
| 7                   | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| SCDT3               | SCDT2 | SCDT1 | SCDT0 | SCDV3 | SCDV2 | SCDV1 | SCDV0 |

This register selects the short-circuit threshold voltage and delay for discharge.

SCD(b3–b0) with corresponding SC threshold voltage with 0000 as the default.

SCD(b3–b0): These bits select the value of the short-circuit voltage threshold

|      |         |      |         |      |         |      |         |
|------|---------|------|---------|------|---------|------|---------|
| 0000 | 0.10 V  | 0100 | 0.20 V  | 1000 | 0.30 V  | 1100 | 0.40 V  |
| 0001 | 0.125 V | 0101 | 0.225 V | 1001 | 0.325 V | 1101 | 0.425 V |
| 0010 | 0.150 V | 0110 | 0.250 V | 1010 | 0.350 V | 1110 | 0.450 V |
| 0011 | 0.175 V | 0111 | 0.275 V | 1011 | 0.375 V | 1111 | 0.475 V |

SCD(b7–b4): These bits select the value of the short-circuit delay time. Exceeding the short-circuit voltage threshold for longer than this period will turn off the corresponding CHG, DSG, and ZVCHG output as has 0000 as the default.

SCD(b7–b4) with corresponding SC delay time

|      |             |      |             |      |             |      |             |
|------|-------------|------|-------------|------|-------------|------|-------------|
| 0000 | 0 $\mu$ s   | 0100 | 244 $\mu$ s | 1000 | 488 $\mu$ s | 1100 | 732 $\mu$ s |
| 0001 | 61 $\mu$ s  | 0101 | 305 $\mu$ s | 1001 | 549 $\mu$ s | 1101 | 793 $\mu$ s |
| 0010 | 122 $\mu$ s | 0110 | 366 $\mu$ s | 1010 | 610 $\mu$ s | 1110 | 854 $\mu$ s |
| 0011 | 183 $\mu$ s | 0111 | 427 $\mu$ s | 1011 | 671 $\mu$ s | 1111 | 915 $\mu$ s |

## APPLICATION INFORMATION

### Precharge and 0-V Charging—Theory of Operation

In order to charge, the charge FET (CHG-FET) must be turned on to create a current path. When the  $V_{(BAT)}$  is 0 V and CHG-FET = ON, the  $V_{(PACK)}$  is as low as the battery voltage. In this case, the supply voltage for the device is too low to operate. There are 3 possible configurations for this function and the bq29312 can be easily configured according to the application needs. The 3 modes are 0-V Charge FET Mode, Common FET Mode and Precharge FET Mode.

1. 0-V Charge FET Mode – Dedicates a precharge current path using an additional FET (ZVCHG-FET) to sustain the PACK+ voltage level. The host charger is expected to provide a precharge function.
2. Common FET Mode – Does not use a dedicated precharge FET. The charge FET (CHG-FET) is assured to be set to ON state as default. The charger is expected to provide a precharge function.
3. Precharge FET Mode – Dedicates a precharge current path using an additional open drain (OD) pin drive FET (PCHG-FET) FET to sustain the PACK+ voltage level. The charger does not provide any precharge function.

### 0-V Charge FET Mode

In this mode, a dedicated precharge current path using an additional FET (ZVCHG-FET) is required to sustain a suitable PACK+ voltage level. The charger is expected to provide the precharge function in this mode where the precharge current level is suitable to charge cells below a set level, typically below 3 V per cell. When the lowest cell voltage rises above this level, then a fast charging current is applied by the charger.

The circuit diagram for this method is shown in Figure 7, showing how the additional FET is added in parallel with the charge FET (CHG-FET).

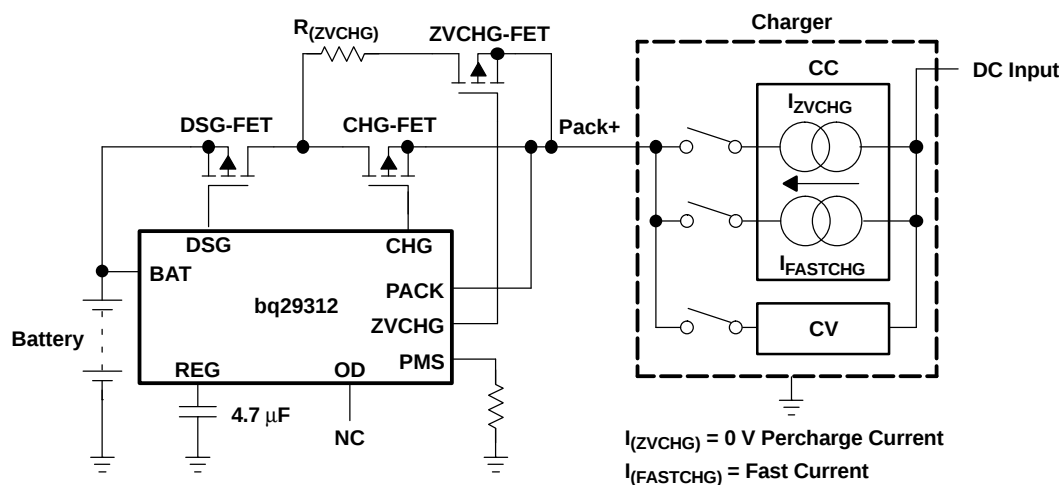
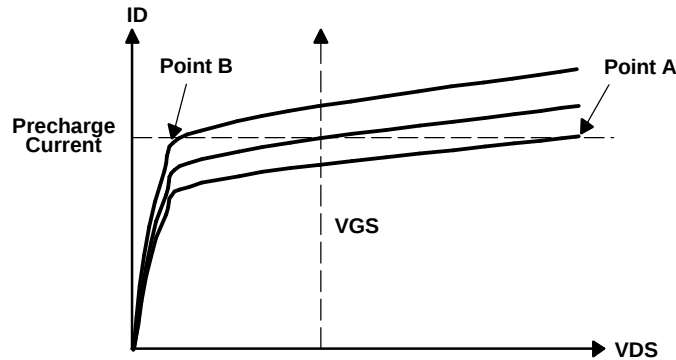


Figure 7. 0-V Charge FET Mode Circuit

## APPLICATION INFORMATION (continued)

In order to pass 0 V or precharge current an appropriate gate-source voltage  $V_{(GS)}$ , for ZVCHG-FET must be applied. Here,  $V_{(PACK)}$  can be expressed in terms of  $V_{(GS)}$  as follows:

$$V_{(PACK)} = V_{(ZVCHG)} + V_{(GS)}(\text{ZVCHG-FET gate - source voltage})$$



**Figure 8. Drain Current vs Drain-Source Voltage Characteristics**

In the bq29312, the initial state is for CHG-FET = OFF and ZVCHG-FET = ON with the  $V_{(ZVCHG)}$  clamped at 3.5 V initially. Then the charger applies a constant current and raises  $V_{(PACK)}$  high enough to pass the precharge current, point A. For example, if the  $V_{(GS)}$  is 2 V at this point,  $V_{(PACK)}$  is 3.5 V + 2 V = 5.5 V. Also, the ZVCHG-FET is used in its MOS saturation region at this point so that  $V_{(DS)}$  is expressed as follows:

$$V_{(PACK)} = V_{(BAT)} + V_F + V_{DS(\text{ZVCHG-FET})}$$

where  $V_F = 0.7$  V is the forward voltage of a DSG-FET back diode and is typically 0.7 V.

This derives the following equation:

$$V_{DS} = 4.8 \text{ V} - V_{(BAT)}$$

As the battery is charged  $V_{(BAT)}$  increases and the  $V_{(DS)}$  voltage decreases reaching its linear region. For example: If the linear region is 0.2 V, this state continues until  $V_{(BAT)} = 4.6$  V, (4.8 V - 0.2 V).

As  $V_{(BAT)}$  increases further,  $V_{(PACK)}$  and the  $V_{(GS)}$  voltage increase. But the  $V_{DS}$  remains at 0.2 V because the ZVCHG-FET is driven in its MOS linear region, point B.

$$V_{(PACK)} = V_F + 0.2 \text{ V} + V_{(BAT)}$$

where  $V_F = 0.7$  V is the forward voltage of a DSG-FET back diode and is typically 0.7 V

The  $R_{(ZVCHG)}$  purpose is to split heat dissipation across the ZVCHG-FET and the resistor.

ZVCHG pin behavior is shown in Figure 9 where  $V_{(ZVCHG)}$  is set to 0 V at the beginning.

## APPLICATION INFORMATION (continued)

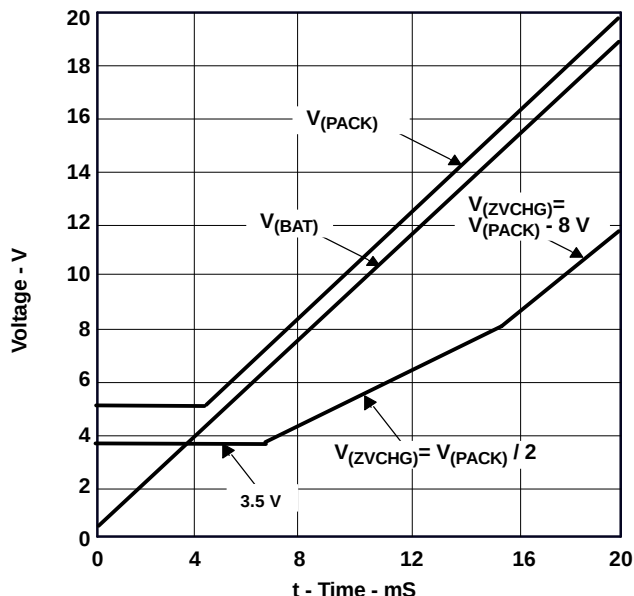
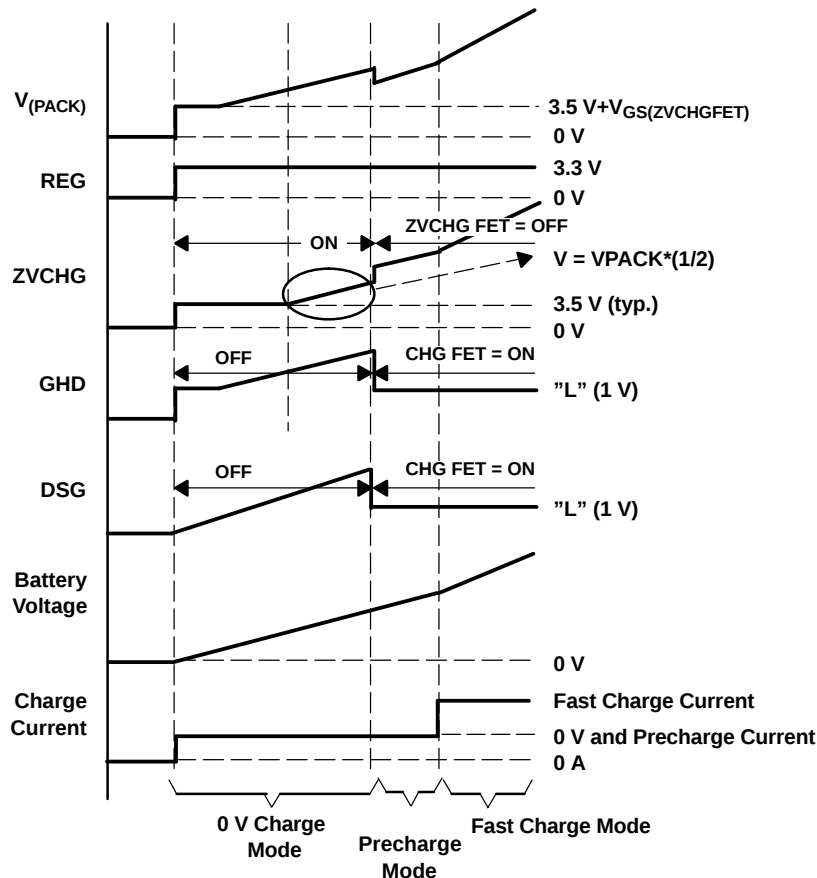


Figure 9. Voltage Transition at ZVCHG, PACK and BAT

As  $V_{(PACK)}$  exceeds 7 V,  $V_{(ZVCHG)} = V_{(PACK)} / 2$ . However,  $V_{(ZVCHG)}$  is maintained to limit the voltage between PACK and ZVCHG at a maximum of 8 V(typ). This limitation is intended to avoid excessive voltage between the gate and the source of ZVCHG-FET.

The signal timing is shown in Figure 10. When precharge begins ( $V_{(BAT)} = 0V$ )  $V_{(PACK)}$  is clamped to 3.5 V and holds the supply voltage for bq29312 operation. After  $V_{(BAT)}$  reaches sufficient voltage high enough for bq29312 operation, the CHG-FET and the DSG-FET are turned ON and ZVCHG-FET is turned OFF.

Although the current path is changed, the same precharging current is still applied. When  $V_{(BAT)}$  reaches the fast charging voltage (typical 3 V per cell), the charger switches into fast charging mode.

**APPLICATION INFORMATION (continued)****Figure 10. Signal Timing of Pins During 0 V Charging and Precharging (0 V Charge FET)****Common FET**

This mode does not require a dedicated precharge FET (ZVCHG-FET). The charge FET (CHG-FET) is ON at initialization of the bq29312 when  $PMS = V_{(PACK)}$  allowing for 0 V or precharge current to flow. The application circuit is shown in Figure 11. The charger is expected to provide the precharge function in this mode, where the charger provides a precharge current level suitable to charge cells below a set level, typically below 3.0 V per cell. When the lowest cell voltage rises above this level then a fast charging current is applied.

When the charger is connected the voltage at PMS rises. Once it is above 0.7 V, the CHG output is driven to GND which turns ON the CHG-FET. The charging current flows through the CHG-FET and a back diode of DSG-FET. The pack voltage is represented by the following equation.

$$V_{(PACK)} = V_{(BAT)} + V_F + V_{DS(CHG-FET)}$$

Where  $V_F = 0.7$  V is the forward voltage of a DSG-FET back diode and is typically 0.7 V.

While  $V_{(PACK)}$  is maintained above 0.7 V the precharging current is maintained. While  $V_{(PACK)}$  and  $V_{(BAT)}$  are under the bq29312 supply voltage then the bq29312 regulator is inactive and the host controller is not functional. Thus, any protection features of this chipset do not function during this period. This state continues until  $V_{(PACK)}$  goes higher than the bq29312 minimum supply voltage.

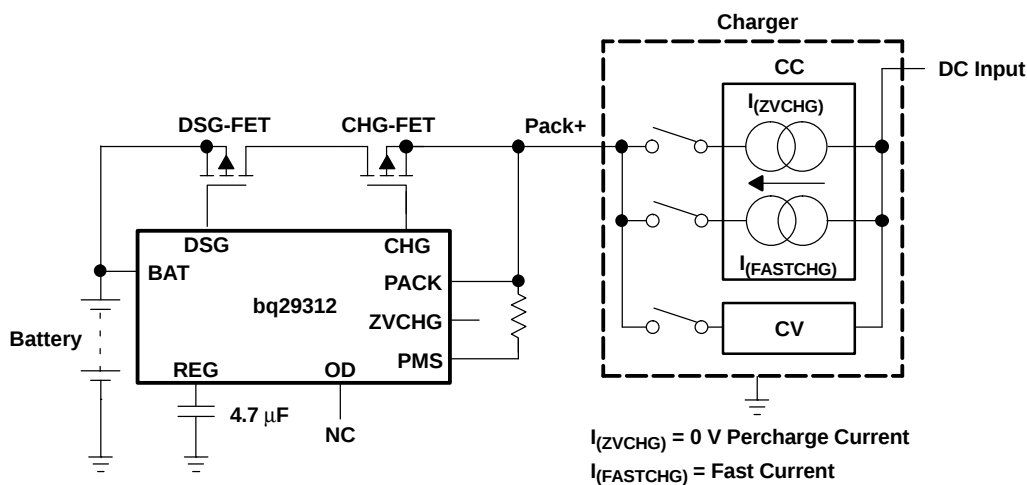
When  $V_{(BAT)}$  rises and  $V_{(PACK)}$  reaches bq29312 minimum supply voltage, the REG output is active providing a 3.3 V (typ) supply to the host. When this level is reached the CHG pin changes its state from GND to the level controlled with CHG bit in bq29312 registers. In this state, the CHG output level is driven by a clamp circuit so that its voltage level changes from 0 V to 1 V. Also, the host controller is active and can turn ON the DSG-FET.

**APPLICATION INFORMATION (continued)**

The disadvantages is that during 0 V charging, bq29312 is inactive. The device does not protect the battery and does not update battery information (now is 0 V charging) to the PC.

There are two advantage of this configuration:

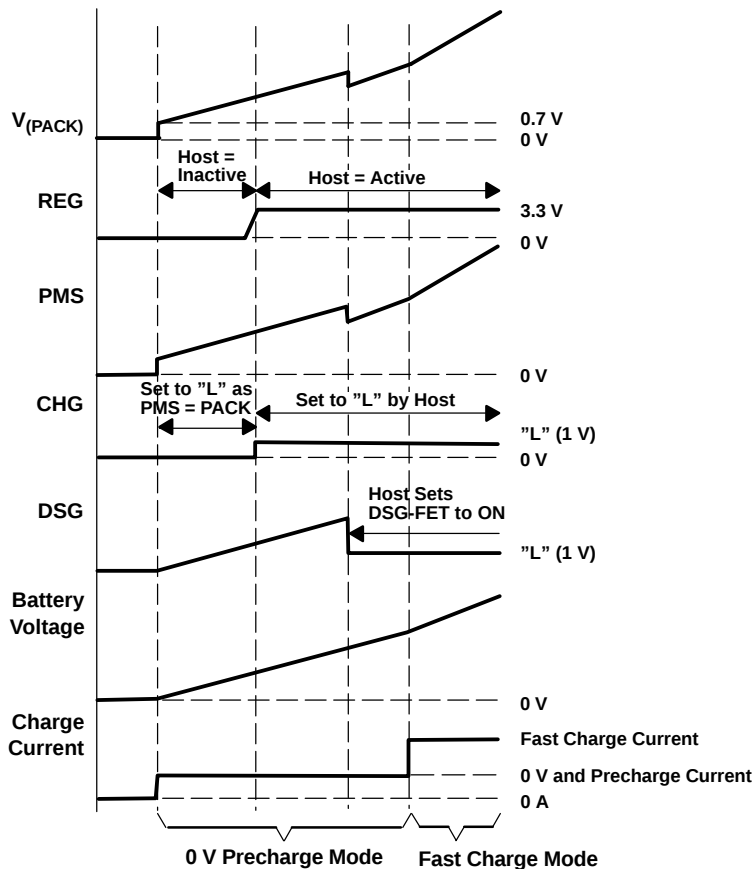
1. The voltage between BAT and PACK is lower. Higher precharge current is allowed due to less heat loss in the FET and no external resistor required.
2. The charge FET is turned on during precharging. The precharge current can be fully controlled by the charger.



**Figure 11. Common FET Mode Circuit Diagram**

The signal timing during the common FET mode is shown in Figure 12. The CHG-FET is turned on when the charger is connected. As  $V_{(BAT)}$  rises and  $V_{(PACK)}$  reaches the bq29312 minimum supply voltage, the REG output becomes active and the host controller starts to work.

When  $V_{(PACK)}$  becomes high enough, the host controller turns ON the DSG-FET. The charger enters the fast charging mode when  $V_{(BAT)}$  reaches the fast charge level.

**APPLICATION INFORMATION (continued)****Figure 12. Signal Timing of Pins During 0 V Charging and Precharging (Common FET)****Precharge FET**

This mode has a dedicated precharge current path using an additional open drain driven FET (PCHG-FET) and sustains the  $V_{(PACK)}$  level. In this mode, where the PMS input is connected to GND, the bq29312 and host combine to provide the precharge function by limiting the fast charge current which is provided by the system side charger.

Figure 13 shows the bq29312 application circuit in this mode.

## APPLICATION INFORMATION (continued)

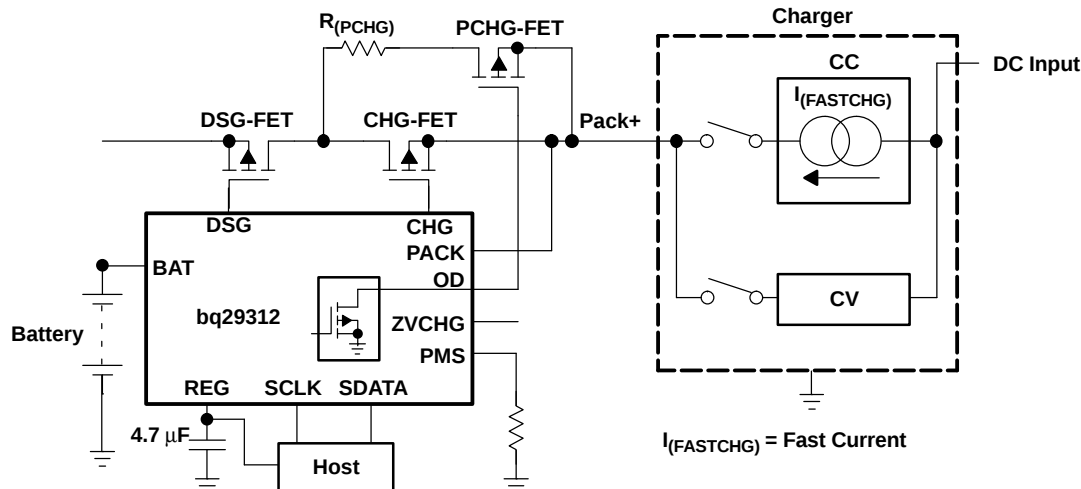


Figure 13. Precharge FET Mode Circuit Diagram

The PCHG-FET is driven by the OD output and the resistor  $R_{(PCHG)}$  in the precharge path limits the precharge current. When  $OD = GND$  then the PCHG-FET is ON. The precharge current is represented by the following equation:

$$I_{(PCHG)} = ID = (V_{(PACK)} - V_{(BAT)} - V_{DS}) / R_{(PCHG)}$$

- A load curve of the PCHG-FET is shown in Figure 14. When the drain-source voltage ( $V_{DS}$ ) is high enough, the PCHG-FET operates in the linear region and has low resistance. By approximating  $V_{DS}$  as 0 V, the precharge current,  $I_{(PCHG)}$  is expressed as below.
- $I_{(PCHG)} = (V_{(PACK)} - V_{(BAT)}) / R_{(PCHG)}$

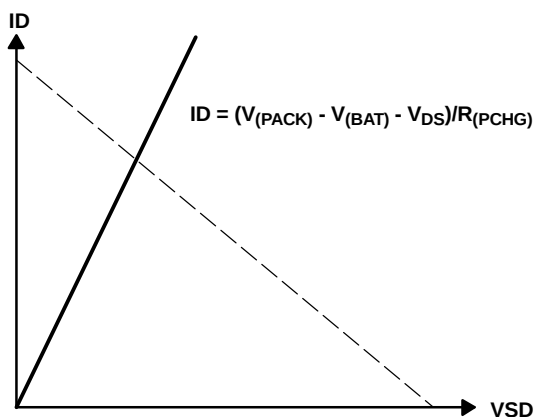


Figure 14. PCHG-FET ID—VDS Characteristic

During the precharge phase, CHG-FET is turned OFF and PCHG-FET is turned ON. When all the cell voltages measured by the host reach the fast charge threshold, the host controller turns ON CHG-FET and turns OFF PCHG-FET. The signal timing is shown in Figure 15.

When the charger is connected, CHG-FET, DSG-FET and PCHG-FET are already in the OFF state. When the charger is connected it applies  $V_{(PACK)}$ . The bq29312 REG output then becomes active and supplies power to the host controller. As the host controller starts up, it turns on the OD pin and the precharge current is enabled.

## APPLICATION INFORMATION (continued)

In this configuration, attention must be paid to high power consumption in the PCHG-FET and the series resistor  $R_{(PCHG)}$ . The highest power is consumed when  $V_{BAT} = 0$  V, where it is the highest differential between the PACK and BAT pins. For example, the power consumption in 4 series cells with 17.4 V fast charge voltage and  $R_{(PCHG)} = 188 \Omega$  is expressed below.

- $I_{PCHG} = (17.4 \text{ V} - 0.0 \text{ V})/188 \Omega = 92.6 \text{ mA}$
- $17.4 \text{ V} \times 92.6 \text{ mA} = 1.61 \text{ W}$

An optional solution is to combine a thermistor with a resistor to create  $R_{(PCHG)}$ , therefore, as temperature increases, the current reduces.

Once the lowest cell voltage reaches the fast charge level (typ 3.0 V per cell), the host controller turns ON CHG-FET and DSG-FET, and turns OFF PCHG-FET.

It is also appropriate to turn on DSG-FET during precharge in order to supply precharge current efficiently, as shown in Figure 15.

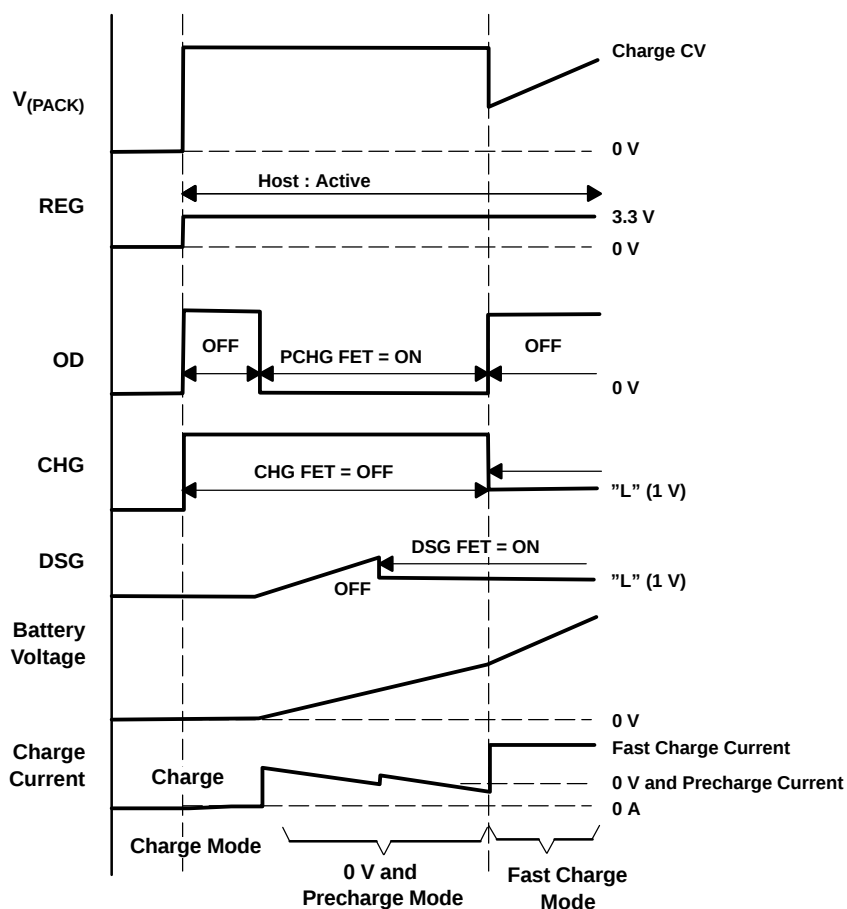


Figure 15. Signal Timing of Pins During 0 V Charging and Precharging (Precharge FET)

## APPLICATION INFORMATION (continued)

### Summary

The three types of 0-V charge options available with the bq29312 are summarized in Table 4.

**Table 4. Charge Options**

| CHARGE MODE TYPE  | HOST CHARGE CAPABILITIES              | KEY APPLICATION CIRCUIT NOTES                                           |
|-------------------|---------------------------------------|-------------------------------------------------------------------------|
| 1) 0-V Charge FET | Fast charge and precharge             | PMS = GND<br>ZVCHG: Drives 0-V charge FET (ZVCHG-FET)<br>OD: Not used   |
| 2) Common FET     | Fast charge and precharge             | PMS = PACK<br>ZVCHG: Not used<br>OD: Not used                           |
| 3) Precharge FET  | Fast charge but no precharge function | PMS = GND<br>ZVCHG: Not used<br>OD: Drives the precharge FET (PCHG-FET) |

There are a number of tradeoffs between the various 0-V charge modes which are discussed below.

#### • 0-V Charge FET (1) vs Common FET (2)

When the charger has both of precharge and charging functions, there are two types of circuit configuration available.

- 0-V Charge FET – The bq29312 is active even during precharge. Therefore, the host can update the battery status to the system and protect the battery pack by detecting abnormal conditions.
  - A high voltage is applied on the 0-V charge FET at 0-V cell voltage. In order to avoid excessive heat generation the 0-V charge current must be limited.
- Common FET – During 0-V charge the bq29312 and the host are not active. Therefore, they cannot protect the cells and cannot update the battery status to the system.
  - The bq29312 can tolerate high 0-V charge current as heat generation is not excessive.
  - A dedicated FET for the 0-V charge is not required.

#### • 0-V Charge FET (1) vs Precharge FET (3)

The current paths of the 0-V charge FET (1) and Precharge FET (3) modes are the same. If the 0-V charge FET (1) mode is used with chargers without precharge function, the bq29312 consumes extra current of up to 1 mA in order to turn ON the ZVCHG output.

- If the charger has a precharge function - ZVCHG-FET is turned ON only during 0-V charging. In this case, 1 mA increase is not a concern because the charger is connected during the 0-V charging period.
- If the charger does not have precharge function - The ZVCHG-FET must be turned ON during 0-V charging and also precharging. When the battery reaches an over discharged state, it must turn OFF DSG-FET and CHG-FET and turn ON ZVCHG-FET. The reason for this is the battery must keep the 0-V charge path while waiting for a charger to be connected to limit the current.
  - Consuming 1 mA, while waiting for a charger to be connected in over discharge state, is significant if compared to current consumption of other modes.

#### • Precharge FET (3)

If the precharge FET (3) mode is used with a charger with precharge function, care must be taken as limiting the 0-V charge current with resistance may cause some issues. The charger may start fast charge immediately, or detect an abnormal condition.

When the charger is connected, the charger may raise the output voltage to force the precharge current. In order to assure a supply voltage for the bq29312 during 0-V charging, the resistance of a series resistor ( $R_{PCHG}$ ) must be high enough. This may result in a very high  $V_{PACK}$ , and some chargers may detect it as an abnormal condition.

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)            | Lead/Ball Finish<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|----------------------|--------------|-------------------------|---------|
| BQ29312PW        | OBSOLETE      | TSSOP        | PW                 | 24   |                | TBD                        | Call TI                 | Call TI              | -25 to 85    | 29312PW                 |         |
| BQ29312PWG4      | OBSOLETE      | TSSOP        | PW                 | 24   |                | TBD                        | Call TI                 | Call TI              | -25 to 85    |                         |         |
| BQ29312PWR       | NRND          | TSSOP        | PW                 | 24   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-1-260C-UNLIM   | -25 to 85    | 29312PW                 |         |
| BQ29312PWRG4     | NRND          | TSSOP        | PW                 | 24   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-1-260C-UNLIM   | -25 to 85    | 29312PW                 |         |
| BQ29312RGE       | OBSOLETE      | VQFN         | RGE                | 24   |                | TBD                        | Call TI                 | Call TI              |              |                         |         |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**
**REEL DIMENSIONS**

**TAPE DIMENSIONS**

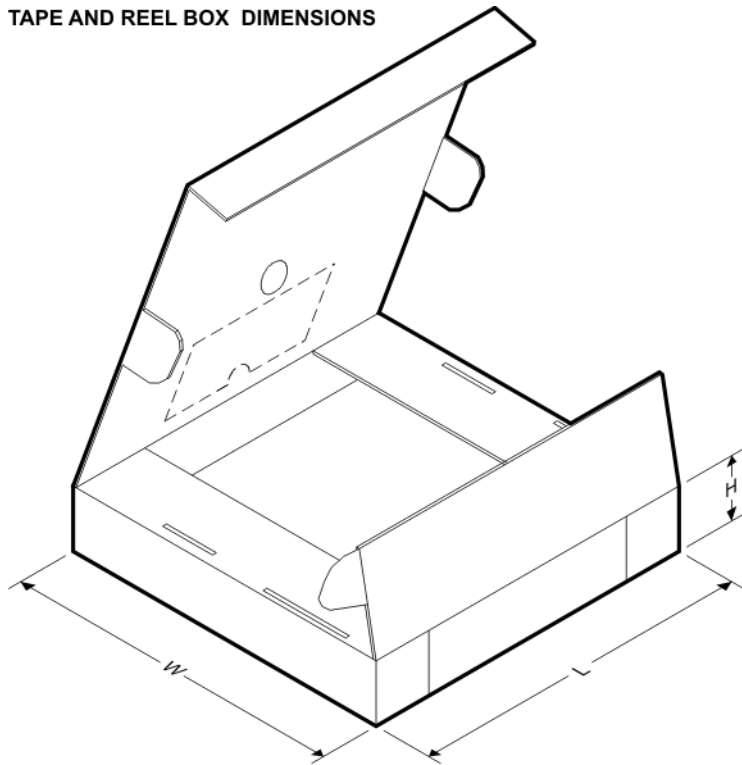

|    |                                                           |
|----|-----------------------------------------------------------|
| A0 | Dimension designed to accommodate the component width     |
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

**TAPE AND REEL INFORMATION**

\*All dimensions are nominal

| Device     | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| BQ29312PWR | TSSOP        | PW              | 24   | 2000 | 330.0              | 16.4               | 6.95    | 8.3     | 1.6     | 8.0     | 16.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS

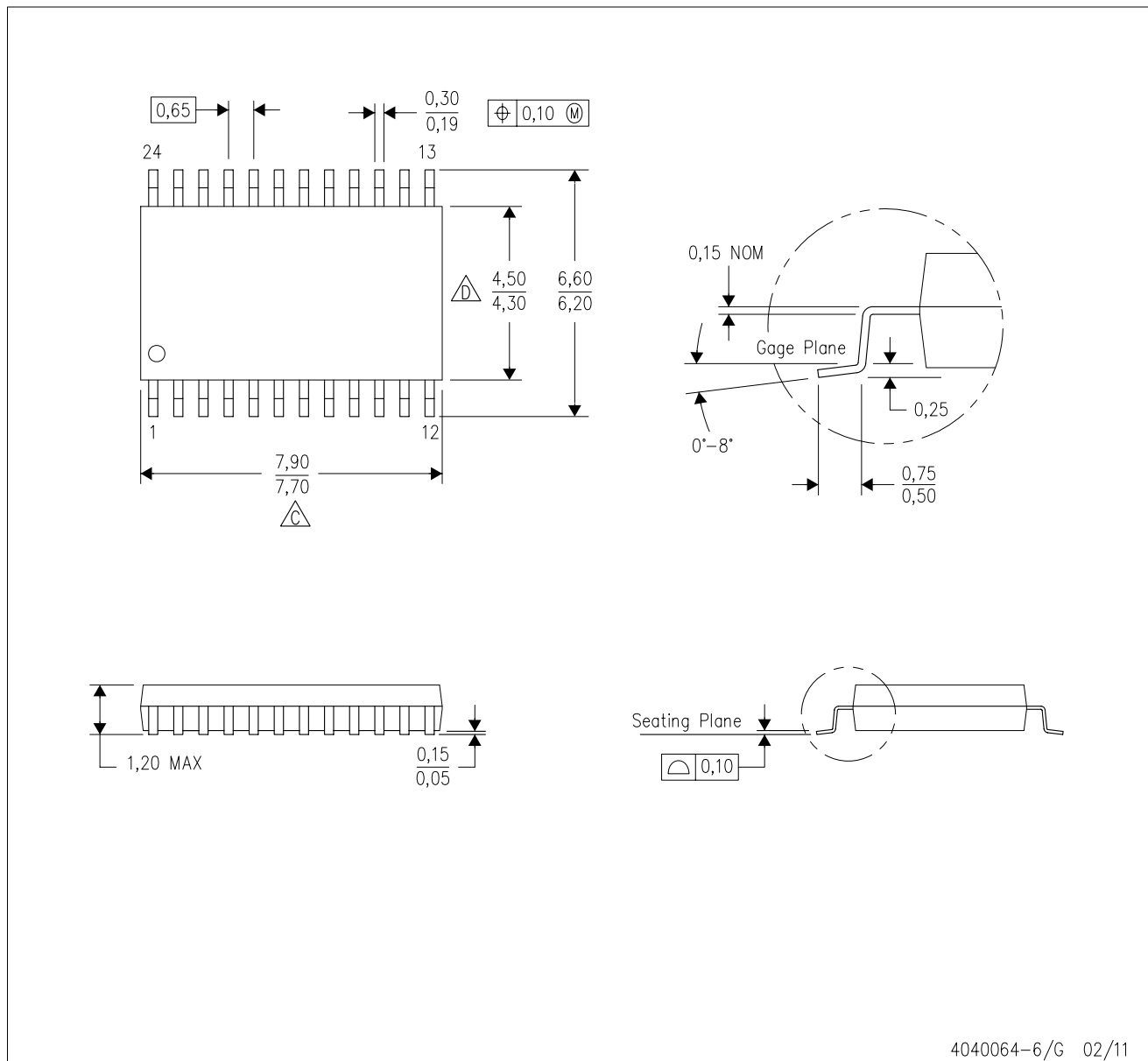


\*All dimensions are nominal

| Device     | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------|--------------|-----------------|------|------|-------------|------------|-------------|
| BQ29312PWR | TSSOP        | PW              | 24   | 2000 | 367.0       | 367.0      | 38.0        |

PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE

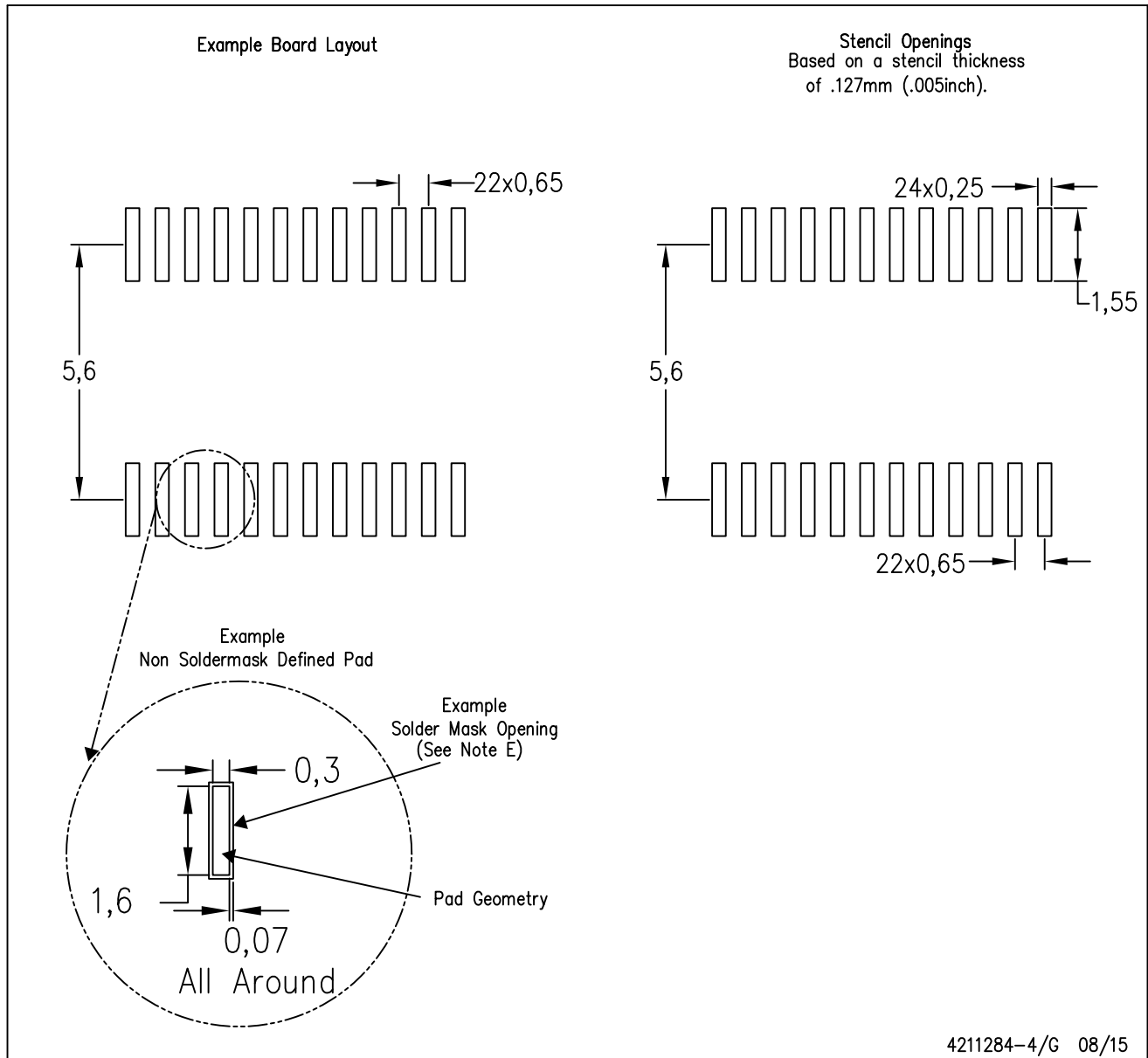


4040064-6/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G24)

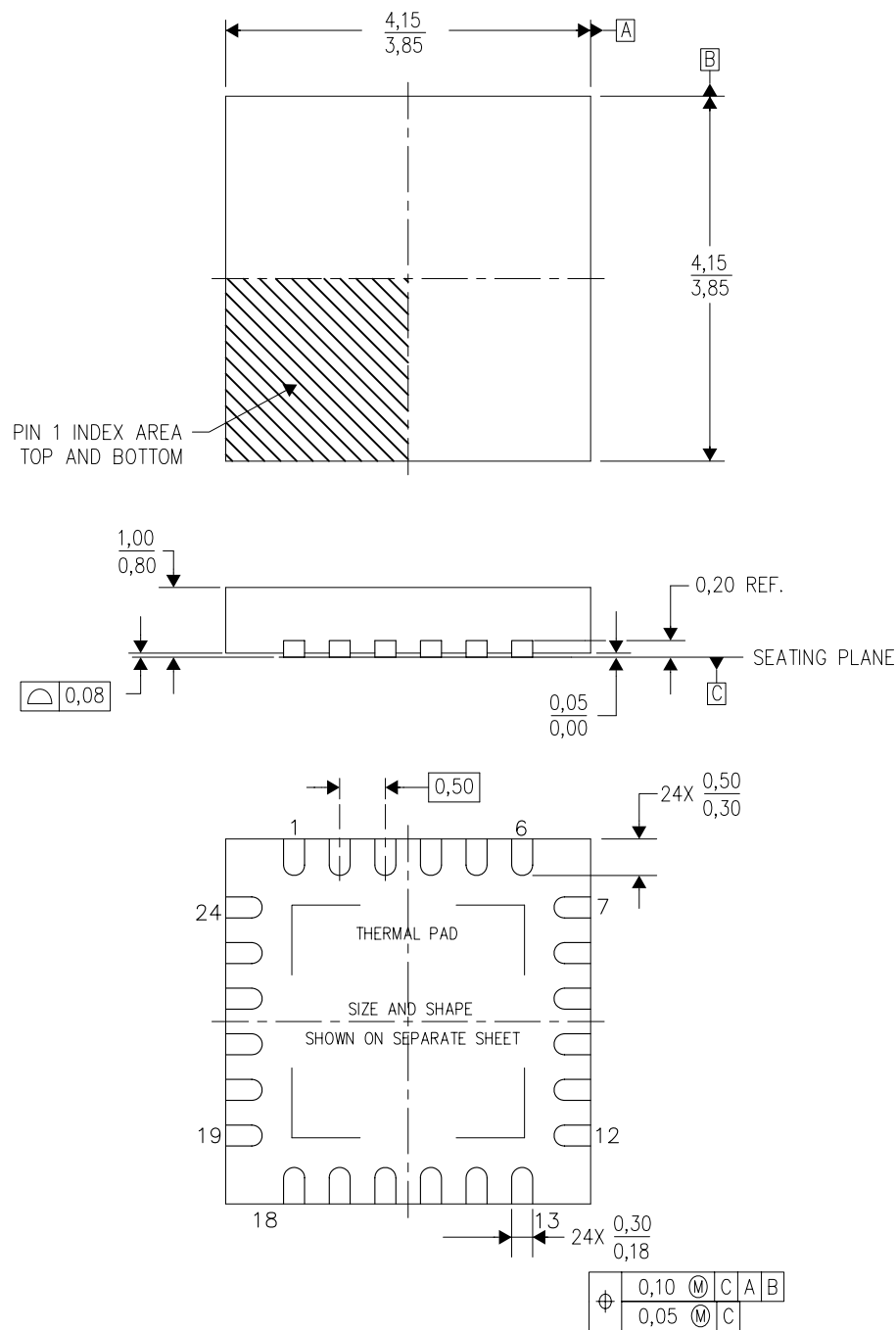
PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate design.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

RGE (S-PVQFN-N24)

PLASTIC QUAD FLATPACK NO-LEAD



4204104/G 07/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Quad Flatpack, No-Leads (QFN) package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - F. Falls within JEDEC MO-220.

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| RFID                         | <a href="http://www.ti-rfid.com">www.ti-rfid.com</a>                                 |
| OMAP Applications Processors | <a href="http://www.ti.com/omap">www.ti.com/omap</a>                                 |
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### Applications

|                               |                                                                                          |
|-------------------------------|------------------------------------------------------------------------------------------|
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